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## 4-BIT SINGLE-CHIP MICROCOMPUTER

**DESCRIPTION**

The  $\mu$ PD75P308 is a model of the  $\mu$ PD75308 equipped with a one-time PROM or EPROM instead of an internal mask ROM.

Two types are available as the  $\mu$ PD75P308. The one-time PROM type is ideal for production of a small quantity of many different types of application systems as data can only be written once to the one-time PROM of this type. Programs can be written and rewritten to the built-in EPROM type making it ideal for system evaluation.

Detailed functions are described in the following user's manual. Be sure to read it for designing.  
 $\mu$ PD75308 User's Manual: IEM-5016

**FEATURES**

- $\mu$ PD75308 compatible
- Memory capacity
  - Program memory (PROM): 8064 x 8 bits
  - Data memory (RAM): 512 x 4 bits
- Can be connected to a pull-up resistor through software: Ports 0-3, 6, 7
- Open-drain input/output: Ports 4 and 5
- Single power source: 5V  $\pm$  5%

**ORDERING INFORMATION**

| Part Number          | Package                            | Internal ROM  |
|----------------------|------------------------------------|---------------|
| $\mu$ PD75P308GF-3B9 | 80-pin plastic QFP (14 x 20 mm)    | One-time PROM |
| $\mu$ PD75P308K      | 80-pin ceramic WQFN (LCC w/window) | EPROM         |

**QUALITY GRADE**

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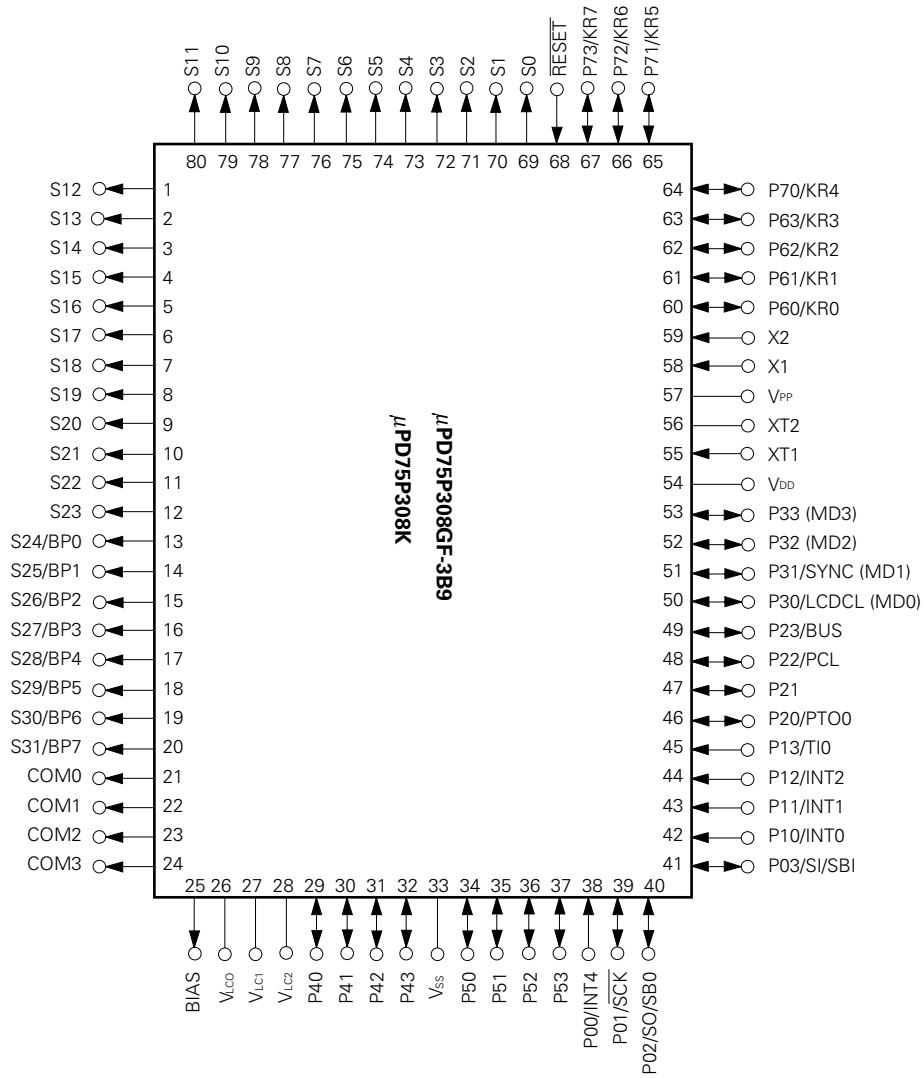
| Part Number              | Package                            | Quality Grade |
|--------------------------|------------------------------------|---------------|
| $\mu$ PD75P308GF-001-3B9 | 80-pin plastic QFP (14 x 20 mm)    | Standard      |
| $\mu$ PD75P308K          | 80-pin Ceramic WQFN (LCC w/window) | Standard      |

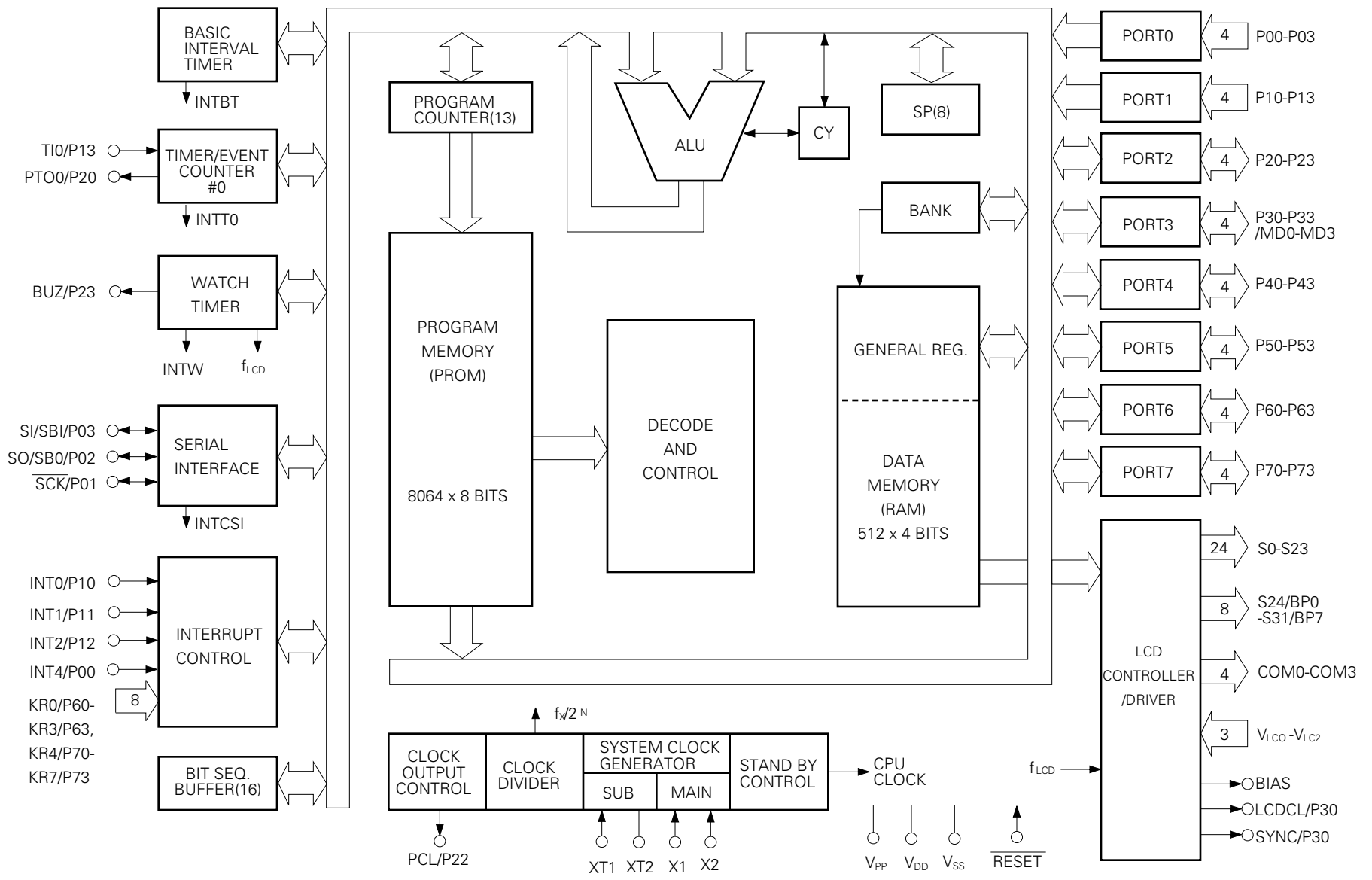
Please refer to "Quality Grade on NEC Semiconductor Devices" (Document number IEI-1209) published by NEC Corporation to know the specification of quality grade on the devices and its recommended applications.

The function common to the one-time PROM and EPROM types of product is referred to as PROM throughout this document.

The information in this document is subject to change without notice.

**PIN CONFIGURATION**





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1. PIN FUNCTIONS

1.1 PORT PINS

| Pin Name  | Input/Output | Also Served As | Function   | 8-Bit I/O | When Reset     | Input/Output Circuit TYPE*1 |
|-----------|--------------|----------------|--|-----------|----------------|-----------------------------|
| P00       | Input        | INT4           | 4-bit input port (PORT0)<br>Pull-up resistors can be specified in 3-bit units for the P01 to P03 pins by software.   | X         | Input          | (B)                         |
| P01       | Input/Output | SCK            |  |           |                |                             |
| P02       | Input/Output | SO/SB0         |  |           |                |                             |
| P03       | Input/Output | SI/SBI         |  |           |                |                             |
| P10       | Input        | INT0           | 4-bit input port (PORT1)<br>Internal pull-up resistors can be specified in 4-bit units by software.  | X         | Input          | (B)-C                       |
| P11       |              | INT1           |  |           |                |                             |
| P12       |              | INT2           |  |           |                |                             |
| P13       |              | TIO            |  |           |                |                             |
| P20       | Input/Output | PTO0           | 4-bit input/output port (PORT2)<br>Internal pull-up resistors can be specified in 4-bit units by software.   | X         | Input          | E-B                         |
| P21       |              | —              |  |           |                |                             |
| P22       |              | PCL            |  |           |                |                             |
| P23       |              | BUZ            |  |           |                |                             |
| P30*2     | Input/Output | LCDCL MD0      | Programmable 4-bit input/output port (PORT3)<br>This port can be specified for input/output in bit units.<br>Internal pull-up resistors can be specified in 4-bit units by software. | X         | Input          | E-B                         |
| P31*2     |              | SYNC MD1       |  |           |                |                             |
| P32*2     |              | MD2            |  |           |                |                             |
| P33*2     |              | MD3            |  |           |                |                             |
| P40-43*2  | Input/Output | —              | N-ch open-drain 4-bit input/output port (PORT4)<br>Data input/output pin for writing and verifying of program memory (PROM) (lower 4 bits)   | ○         | High impedance | M-A                         |
| P50-P53*2 | Input/Output | —              | N-ch open-drain 4-bit input/output port (PORT5)<br>Data input/output pin for writing and verifying of program memory (PROM) (upper 4 bits)   |           | High impedance | M-A                         |
| P60       | Input/Output | KR0            | Programmable 4-bit input/output port (PORT6)<br>This port can be specified for input/output in bit units.<br>Internal pull-up resistors can be specified in 4-bit units by software. | ○         | Input          | (F)-A                       |
| P61       |              | KR1            |  |           |                |                             |
| P62       |              | KR2            |  |           |                |                             |
| P63       |              | KR3            |  |           |                |                             |
| P70       | Input/Output | KR4            | 4-bit input/output port (PORT7)<br>Internal pull-up resistors can be specified in 4-bit units by software.   | ○         | Input          | (F)-A                       |
| P71       |              | KR5            |  |           |                |                             |
| P72       |              | KR6            |  |           |                |                             |
| P73       |              | KR7            |  |           |                |                             |
| BP0       | Output       | S24            | 1-bit output port (BIT PORT)<br>Shared with a segment output pin.  | X         | *3             | G-C                         |
| BP1       |              | S25            |  |           |                |                             |
| BP2       |              | S26            |  |           |                |                             |
| BP3       | S27          |                |  |           |                |                             |
| BP4       | Output       | S28            |  |           |                |                             |
| BP5       |              | S29            |  |           |                |                             |
| BP6       |              | S30            |  |           |                |                             |
| BP7       |              | S31            |  |           |                |                             |

\*1: Circles indicate schmitt trigger inputs.

2: Can directly drive LED.

3: For BP0-7, V<sub>LC1</sub> indicated below are selected as the input source.

However, the output level is changed depending on BP0-7 and the V<sub>LC1</sub> external circuits.



1.2 NON PORT PINS

| Pin Name                           | Input/Output | Also Served As | Function   | When Reset     | Input/Output Circuit TYPE <sup>*1</sup> |
|------------------------------------|--------------|----------------|--|----------------|---|
| TI0                                | Input        | P13            | Timer/event counter external event pulse input   | —              | (B)-C                                   |
| PTO0                               | Output       | P20            | Timer/event counter output   | Input          | E-B                                     |
| PCL                                | Input/Output | P22            | Clock output   | Input          | E-B                                     |
| BUZ                                | Input/Output | P23            | Fixed frequency output (for buzzer or for trimming the system clock)   | Input          | E-B                                     |
| SCK                                | Input/Output | P01            | Serial clock input/output  | Input          | (F)-A                                   |
| SO/SB0                             | Input/Output | P02            | Serial data output<br>Serial bus input/output  | Input          | (F)-B                                   |
| SI/SB1                             | Input/Output | P03            | Serial data input<br>Serial bus input/output   | Input          | (M)-C                                   |
| INT4                               | Input        | P00            | Edge detection vector interrupt input (either rising or falling edge detection is effective)   | —              | (B)                                     |
| INT0                               | Input        | P10            | Edge detection vector interrupt input (detection edge can be selected)   | —              | (B)-C                                   |
| INT1                               |              | P11            |  |                |   |
| INT2                               | Input        | P12            | Edge detection testable input (rising edge detection)  | —              | (B)-C                                   |
| KR0-KR3                            | Input/Output | P60-P63        | Testable input/output(parallel falling edge detection)   | Input          | (F)-A                                   |
| KR4-KR7                            | Input/Output | P70-P73        | Testable input/output(parallel falling edge detection)   | Input          | (F)-A                                   |
| S0-S23                             | Output       | —              | Segment signal output  | *3             | G-A                                     |
| S24-S31                            | Output       | BP0-7          | Segment signal output  | *3             | G-C                                     |
| COM0-COM3                          | Output       | —              | Common signal output   | *3             | G-B                                     |
| V <sub>LC0</sub> -V <sub>LC2</sub> | —            | —              | LCD drive power  | —              | —                                       |
| BIAS                               | —            | —              | External dividing resistor disconnect output   | High-impedance | —                                       |
| LCDCL <sup>*2</sup>                | Input/Output | P30            | Externally expanded driver clock output  | Input          | E-B                                     |
| SYNC <sup>*2</sup>                 | Input/Output | P31            | Externally expanded driver sync clock output   | Input          | E-B                                     |
| X1, X2                             | Input        | —              | To connect the crystal/ceramic oscillator to the main system clock generator.<br>When inputting the external clock, input the external clock to pin X1, and the reverse phase of the external clock to pin X2.                         | —              | —                                       |
| XT1                                | Input        | —              | To connect the crystal oscillator to the subsystem clock generator.<br>When the external clock is used, in XT1 inputs the external clock. In this case, pin XT2 must be left open.<br>Pin XT1 can be used as a 1-bit input (test) pin. | —              | —                                       |
| XT2                                | —            | —              |  |                |   |
| RESET                              | Input        | —              | System reset input (low level active)  | —              | (B)                                     |
| MD0-MD3                            | Input/Output | P30-P33        | To select mode when writing/verifying of program memory (PROM)   | Input          | E-B                                     |
| V <sub>PP</sub>                    | —            | —              | Program voltage application when writing and verifying of program memory (PROM)<br>Connect to V <sub>DD</sub> during the normal operation<br>Apply +12.5V when writing/verifying EPROM   | —              | —                                       |
| V <sub>DD</sub>                    | —            | —              | Positive power supply  | —              | —                                       |
| V <sub>SS</sub>                    | —            | —              | GND  | —              | —                                       |

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\*1: Circles indicate schmitt trigger inputs.

2: These pins are provided for future system expansion. At present, these pins are used only as pins P30 and P31.

3: For these display output, V<sub>LCX</sub> indicated below are selected as the input source.

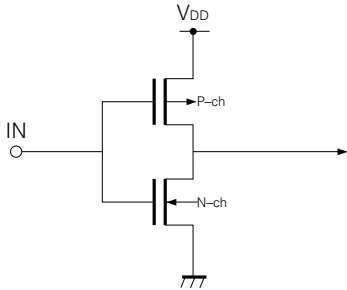
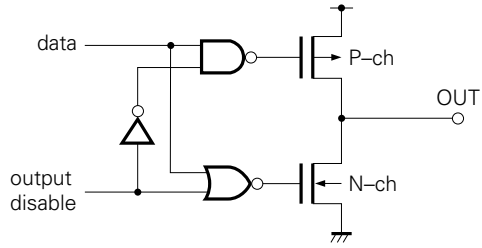
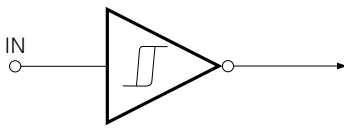
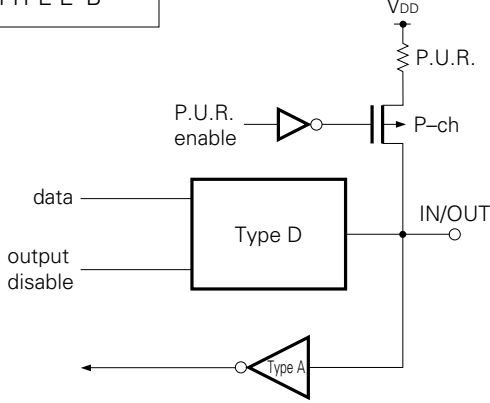
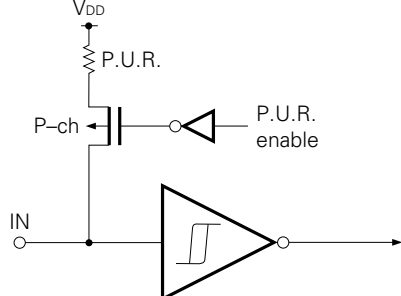
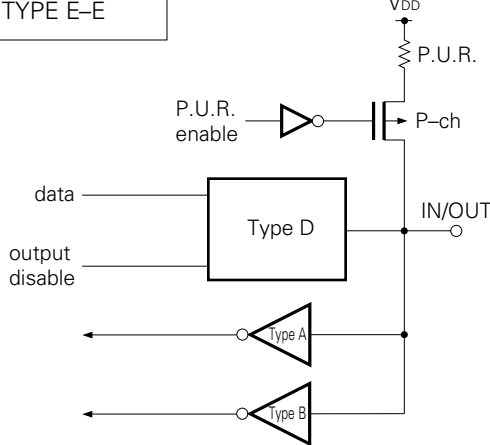
S0 to S31: V<sub>LC1</sub>, COM0 to COM2: V<sub>LC2</sub>, COM3: V<sub>LC0</sub>

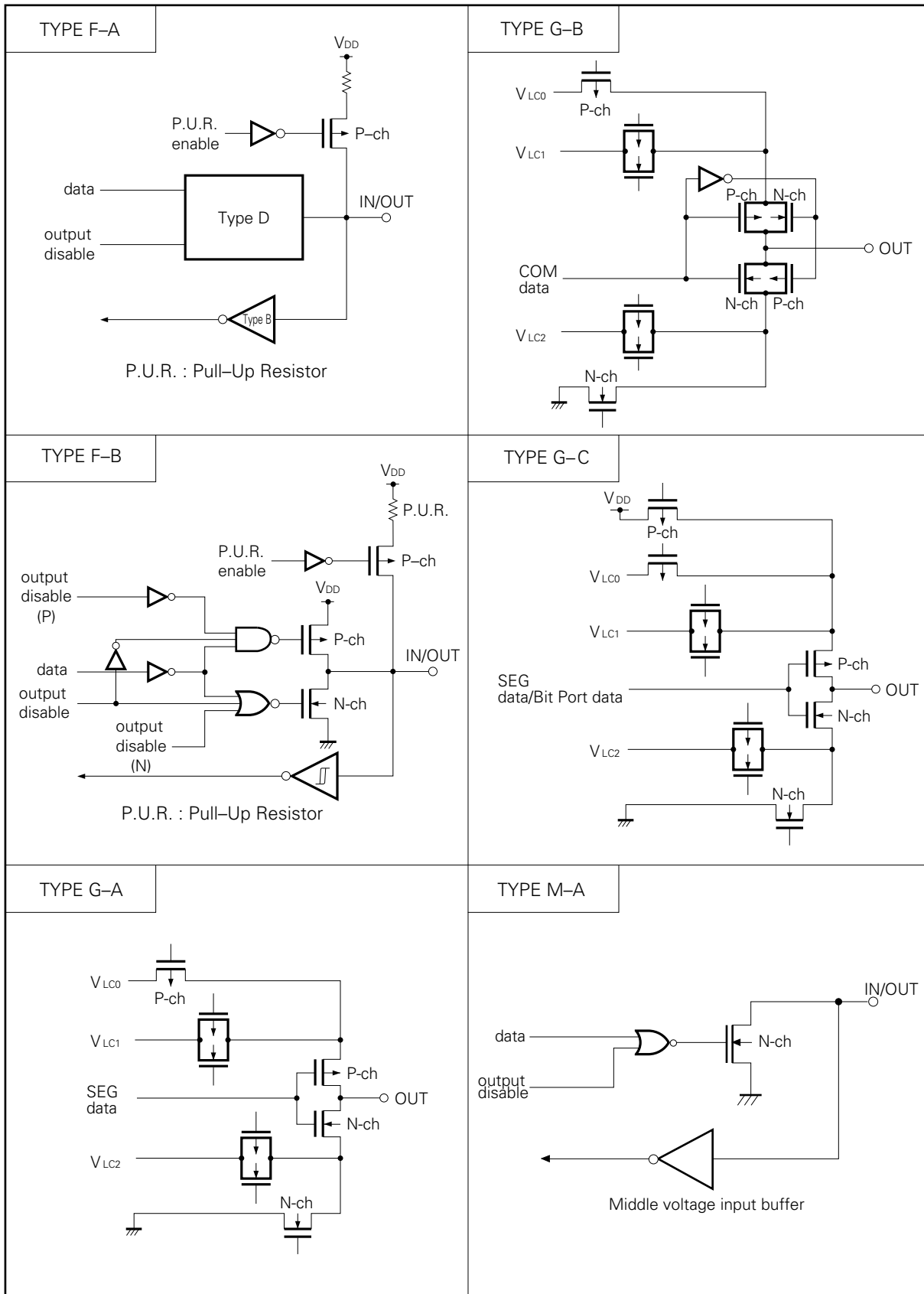
However, display output level varies depending on the particular display output and V<sub>LCX</sub> external circuit.

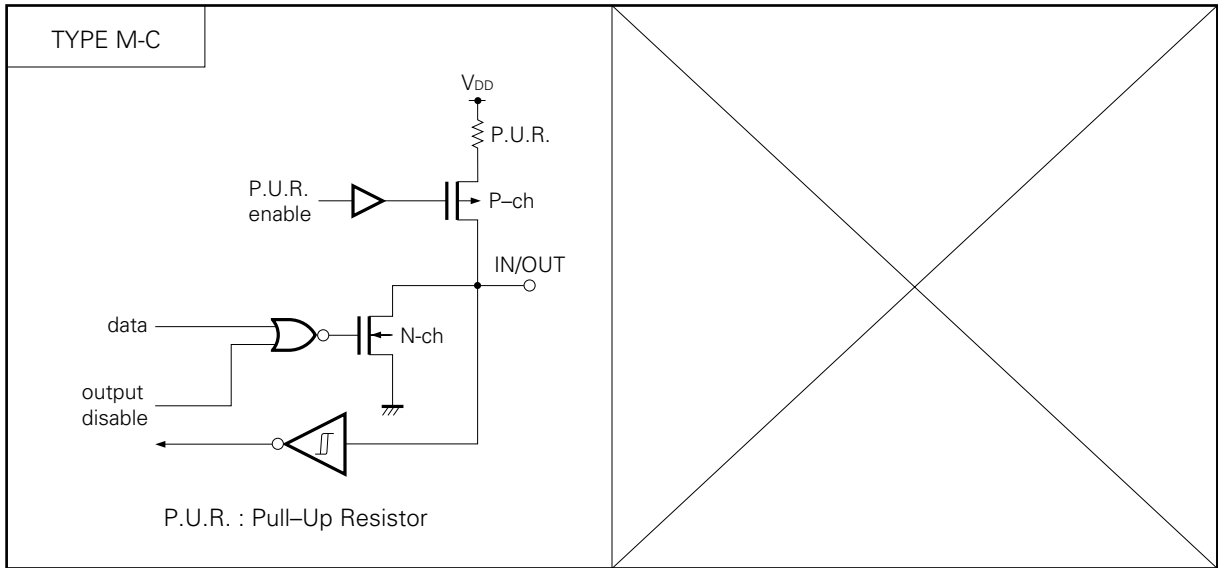


**1.3 PIN INPUT/OUTPUT CIRCUITS**

The following shows a simplified input/output circuit diagram for each pin of the  $\mu$ PD75P308.

|   |  |
|---|--|
| <p>TYPE A (for TYPE E-B)</p>  <p>Input buffer of CMOS standard</p>   | <p>TYPE D (for TYPE E-B, F-A)</p>  <p>Push-pull output that can be set in a output high-impedance state (both P-ch and N-ch are off)</p> |
| <p>TYPE B</p>  <p>Schmitt trigger input with hysteresis characteristics</p>                                     | <p>TYPE E-B</p>  <p>P.U.R. : Pull-Up Resistor</p>   |
| <p>TYPE B-C</p>  <p>P.U.R. : Pull-Up Resistor</p> <p>Schmitt trigger input with hysteresis characteristics</p> | <p>TYPE E-E</p>  <p>P.U.R. : Pull-Up Resistor</p>  |





**1.4 NOTES ON USING P00/INT4 AND  $\overline{\text{RESET}}$  PINS**

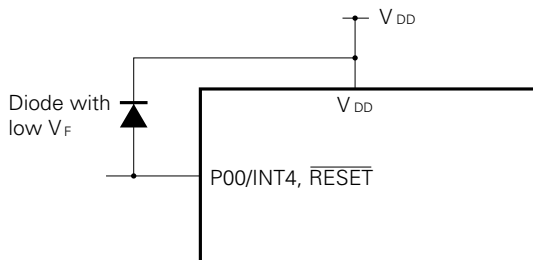
In addition to the functions shown in sections 1.1 and 1.2, the P00/INT4 and  $\overline{\text{RESET}}$  pins also have a function to set a test mode (for IC testing) in which the internal operations of the  $\mu$ PD75P308 are tested.

When a voltage higher than  $V_{DD}$  is applied to either of these pins, the test mode is set. This means that, even during ordinary operation, the  $\mu$ PD75P308 may be set in the test mode if a noise exceeding  $V_{DD}$  is applied.

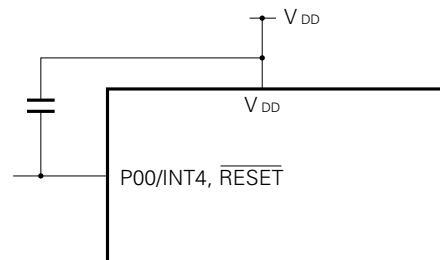
For example, if the wiring length of the P00/INT4 or  $\overline{\text{RESET}}$  pin is too long, noise superimposed on the wiring line of the pin may cause the above problem.

Therefore, keep the wiring length of these pins as short as possible to suppress the noise; otherwise, take noise preventive measures as shown below by using external components.

- Connect diode with low  $V_F$  between  $V_{DD}$  and P00/INT4,  $\overline{\text{RESET}}$  pin



- Connect capacitor between  $V_{DD}$  and P00/INT4,  $\overline{\text{RESET}}$  pin



**2. DIFFERENCES BETWEEN μPD75P308 AND μPD75308**

The μPD75P308 is a model of the μPD75308 and is equipped with a PROM instead of a mask ROM. Programs can be rewritten to the PROM of the μPD75P308. Table 2-1 shows the differences between the μPD75P308 and μPD75308. You should fully consider these differences when you debug or produce your application system on an experimental basis by using the PROM model, and then proceed to mass-produce the system by using the mask ROM model.

For the details of the CPU and the internal hardware, refer to μPD75308 User's Manual (IEM-5016).

**Table 2-1 Differences between μPD75P308 and μPD75308**

| Item   |            | μPD75P308K  | μPD75P308GF   | μPD75308GF   |
|--|------------|---|---|--|
| Program Memory                                 |            | <ul style="list-style-type: none"> <li>• EPROM</li> <li>• 0000H-1F7FH</li> <li>• 8064 x 8 bits</li> </ul>   | <ul style="list-style-type: none"> <li>• PROM (one-time model)</li> <li>• 0000H-1F7FH</li> <li>• 8064 x 8 bits</li> </ul> | <ul style="list-style-type: none"> <li>• Mask ROM</li> <li>• 0000H-1F7FH</li> <li>• 8064 x 8 bits</li> </ul> |
| Pull-up Resistor                               | Ports 4, 5 | Not provided  |   | Mask option  |
| Dividing Resistor for LCD Driving Power Supply |            | Not provided  |   | Mask option  |
| Pin Connection                                 | Pins 50-53 | P30/MD0-P33/MD3   |   | P30-P33  |
|  | Pin 57     | V <sub>PP</sub>   |   | NC   |
| Electrical Specifications                      |            | Current dissipations and operating temperature ranges differ between μPD75P308 and μPD75308. For detail, refer to the specification documents of each mode. |   |  |
| Operating Voltage Range                        |            | 5V±5%   |   | 2.7-6.0V   |
| Package  |            | 80-pin ceramic WQFN (LCC w/window)  | 80-pin plastic QFP (14 x 20 mm)   |  |
| Others   |            | Noise immunity and noise radiation differ because circuit scale and mask layout are different.  |   |  |

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★ *Note:* The noise immunity and noise radiation differ between the PROM and mask ROM models. To replace the PROM model with the mask ROM model in the course of experimental production to mass production, evaluate your system by using the CS mode (not ES model) of the mask ROM model.

### 3. WRITING AND VERIFYING PROM (PROGRAM MEMORY)

The program memory of the  $\mu$ PD75P308 is a PROM of 8064 x 8 bits. To write data to or verify the contents of this PROM, the pins listed in the table below are used. Note that no address input pins are provided because the address is updated by the clock input through the X1 pin.

| Pin Name                               | Function   |
|--|--|
| V <sub>PP</sub>                        | Applies voltage when program memory is written/verified (normally, at V <sub>DD</sub> potential)   |
| X1, X2                                 | These pins input clock that updates address when program memory is written/verified. To X2 pin, input signal 180° out of phase in respect to signal to X1 pin. |
| MD0-MD3                                | These pins select operation mode when program memory is written/verified.  |
| P40-P43 (Lower 4)<br>P50-P53 (Upper 4) | These pins input/output 8-bit data when program memory is written/verified.  |
| V <sub>DD</sub>                        | Power supply voltage application pin.<br>Apply 5V ± 5% to this pin during normal operation and 6V when program memory is written/verified.                     |

*Note 1:* Always cover the erasure window of the  $\mu$ PD75P308K with a light-opaque film except when the contents of the program memory are erased.

*Note 2:* The one-time PROM model  $\mu$ PD75P308GF is not equipped with a window and therefore, the contents of the program memory of this model cannot be erased by exposing it to ultraviolet rays.

#### 3.1 OPERATION MODES FOR WRITING/VERIFYING PROGRAM MEMORY

When +6V is applied to the V<sub>DD</sub> pin of the  $\mu$ PD75P308 with +12.5V applied to the V<sub>PP</sub> pin, the  $\mu$ PD75P308 is set in the program memory write/verify mode. In this mode, the following operation modes can be set by using the MD0-MD3 pins. At this time, pull down the levels of all the other pins to V<sub>ss</sub>.

| Operating Mode Specification |                 |     |     |     |     | Operating Mode                      |
|------------------------------|-----------------|-----|-----|-----|-----|-------------------------------------|
| V <sub>PP</sub>              | V <sub>DD</sub> | MD0 | MD1 | MD2 | MD3 |                                     |
| +12.5 V                      | +6 V            | H   | L   | H   | L   | Program memory address 0 clear mode |
|                              |                 | L   | H   | H   | H   | Write mode                          |
|                              |                 | L   | L   | H   | H   | Verify mode                         |
|                              |                 | H   | x   | H   | H   | Program inhibit mode                |

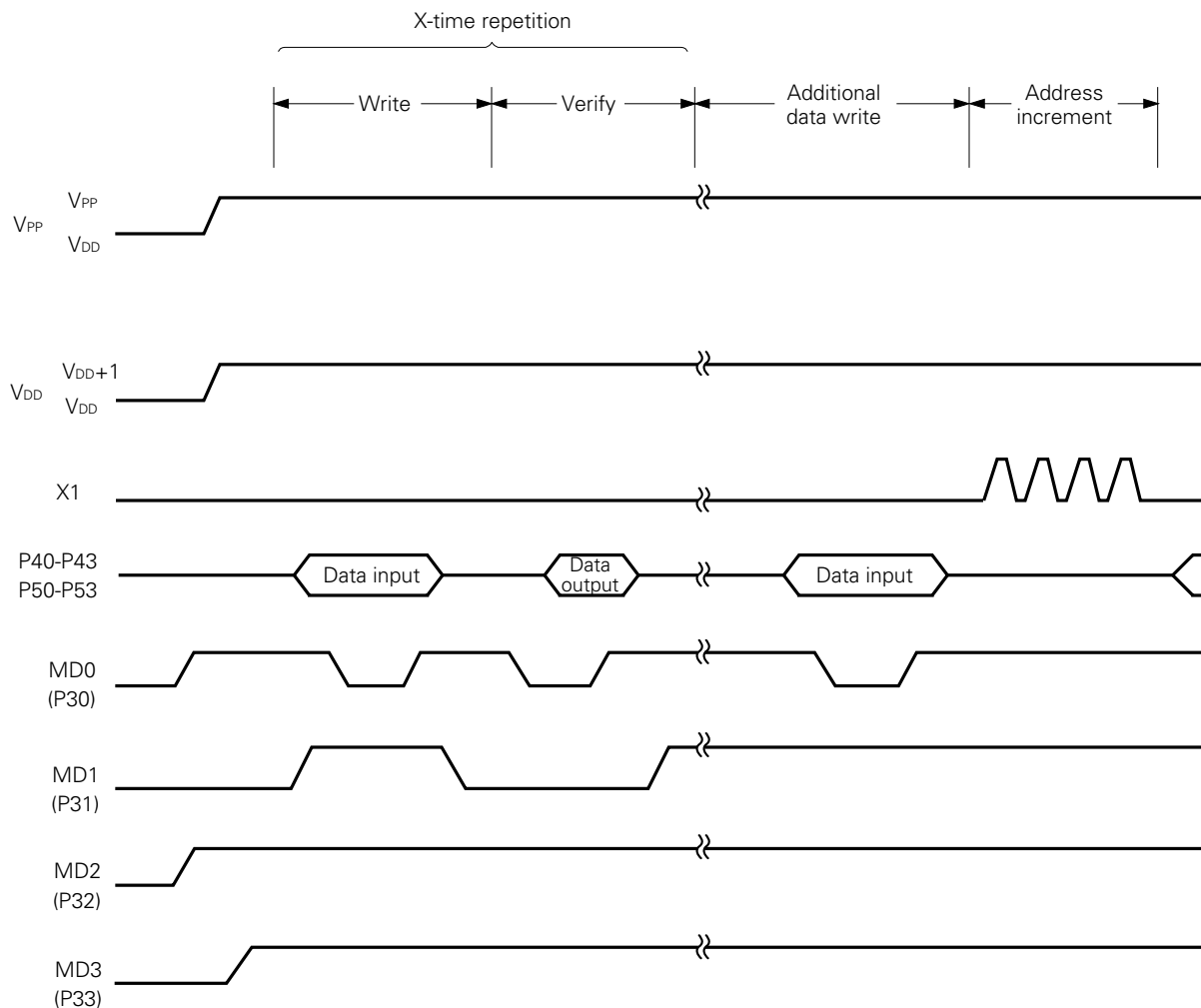
x: L or H

**3.2 PROGRAM MEMORY WRITE PROCEDURE**

The program memory write procedure is as follows. High-speed program memory write is possible.

- (1) Ground the unused pins through pull-down resistors. The X1 pin must be low.
- (2) Supply 5 V to the V<sub>DD</sub> and V<sub>PP</sub> pins.
- (3) Wait for 10 microseconds.
- (4) Set program memory address 0 clear mode.
- (5) Supply 6 V to the V<sub>DD</sub> pin and 12.5 V to the V<sub>PP</sub> pin.
- (6) Set program inhibit mode.
- (7) Write data in 1-millisecond write mode.
- (8) Set program inhibit mode.
- (9) Set verify mode. If data has been written connectly, proceed to step (10). If data has not yet been written, repeat steps (7) to (9).
- (10) Write additional data for (the number of times data was written (X) in steps (7) to (9)) times 1 milliseconds.
- (11) Set program inhibit mode.
- (12) Supply a pulse to the X1 pin four times to update the program memory address by 1.
- (13) Repeat steps (7) to (12) to the last address.
- (14) Set program memory address 0 clear mode.
- (15) Change the voltages of V<sub>DD</sub> and V<sub>PP</sub> pins to 5 V.
- (16) Turn off the power supply.

Steps (2) to (12) are illustrated below.

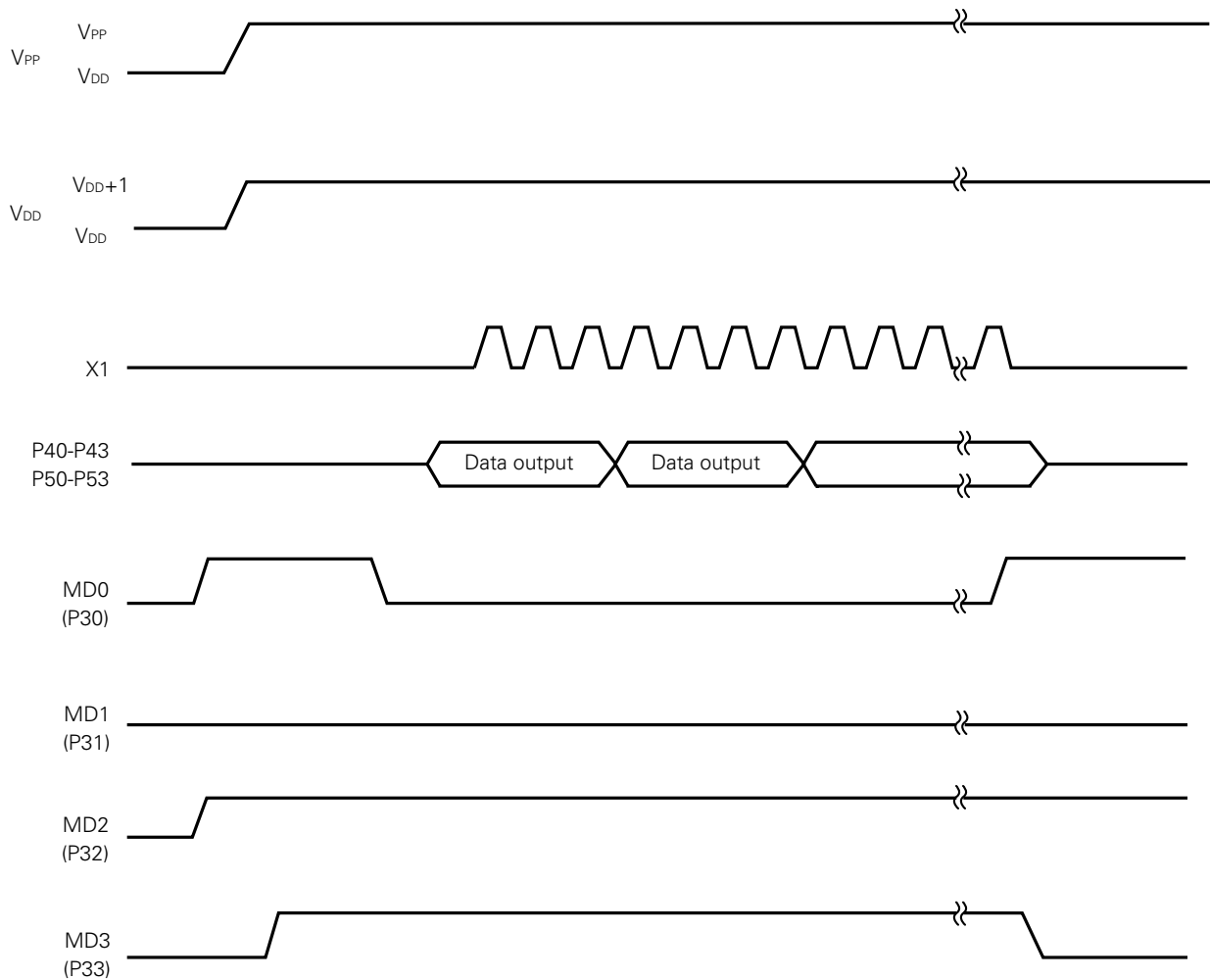


**3.3 PROGRAM MEMORY READ PROCEDURE**

The contents of the program memory can be read in the following procedure.

- (1) Ground the unused pins through pull-down resistors. The X1 pin must be low.
- (2) Supply 5 V to the V<sub>DD</sub> and V<sub>PP</sub> pins.
- (3) Wait for 10 microseconds.
- (4) Set program memory address 0 clear mode.
- (5) Supply 6 V to the V<sub>DD</sub> pin and 12.5 V to the V<sub>PP</sub> pin.
- (6) Set program inhibit mode.
- (7) Set verify mode. Data of each address is sequentially output each time a clock pulse is input to the X1 pin four times.
- (8) Set program inhibit mode.
- (9) Set program memory address 0 clear mode.
- (10) Change the voltages of V<sub>DD</sub> and V<sub>PP</sub> pins to 5 V.
- (11) Turn off the power supply.

Steps (2) to (9) are illustrated below.



### 3.4 ERASURE ( $\mu$ PD75P308K ONLY)

The contents of the data programmed to the  $\mu$ PD75P308 can be erased by exposing the window of the program memory to ultraviolet rays.

The wavelength of the ultraviolet rays used to erase the contents is about 250 nm, and the quantity of the ultraviolet rays necessary for complete erasure is 15 W.s/cm<sup>2</sup> (= ultraviolet ray intensity x erasure time).

When a commercially available ultraviolet ray lamp (wavelength: 254 nm, intensity: 12 mW/cm<sup>2</sup>) is used, about 15 to 20 minutes is required.

*Note 1:* The contents of the program memory may be erased when the  $\mu$ PD75P308 is exposed for a long time to direct sunlight or the light of fluorescent lamps. To protect the contents from being erased, mask the window of the program memory with the light-opaque film supplied as an accessory with the UV EPROM products.

*2:* To erase the memory contents, the distance between the ultraviolet ray lamp and the  $\mu$ PD75P308 should be 2.5 cm or less.

*Remarks:* The time required for erasure changes depending on the degradation of the ultraviolet ray lamp and the surface condition (dirt) of the window of the program memory.



## 4. ELECTRICAL SPECIFICATIONS

ABSOLUTE MAXIMUM RATINGS (T<sub>a</sub> = 25°C)

| Parameter                 | Symbol                        | Conditions                |                 | Rating                       | Unit |
|---------------------------|-------------------------------|---------------------------|-----------------|------------------------------|------|
| Supply Voltage            | V <sub>DD</sub>               |                           |                 | -0.3 to +7.0                 | V    |
| Supply Voltage            | V <sub>PP</sub>               |                           |                 | -0.3 to +13.5                | V    |
| Input Voltage             | V <sub>I1</sub>               | Other than ports 4 or 5   |                 | -0.3 to V <sub>DD</sub> +0.3 | V    |
|                           | V <sub>I2</sub> <sup>*1</sup> | Ports 4 and 5             | Open-drain      | -0.3 to +11                  | V    |
| Output Voltage            | V <sub>O</sub>                |                           |                 | -0.3 to V <sub>DD</sub> +0.3 | V    |
| High-Level Output Current | I <sub>OH</sub>               | 1 Pin                     |                 | -15                          | mA   |
|                           |                               | All pins                  |                 | -30                          | mA   |
| Low-Level Output Current  | I <sub>OH</sub> <sup>*2</sup> | One pin                   | Peak value      | 30                           | mA   |
|                           |                               |                           | Effective value | 15                           | mA   |
|                           |                               | Total of ports 0, 2, 3, 5 | Peak value      | 100                          | mA   |
|                           |                               |                           | Effective value | 60                           | mA   |
|                           |                               | Total of ports 4, 6, 7    | Peak value      | 100                          | mA   |
|                           |                               |                           | Effective value | 60                           | mA   |
| Operating Temperature     | T <sub>opt</sub>              |                           |                 | -10 to +70                   | °C   |
| Storage Temperature       | T <sub>stg</sub>              |                           |                 | -65 to +150                  | °C   |

\*1: The impedance of the power source (pull-up resistor) must be 50 KΩ minimum when a voltage higher than 10V is applied to ports 4 and 5.

\*2: Effective value = Peak value ×  $\sqrt{\text{Duty}}$

**MAIN SYSTEM CLOCK OSCILLATOR CIRCUIT CHARACTERISTICS**

(T<sub>a</sub> = -10 to +70°C, V<sub>DD</sub> = 5 to ±5 V)

| Oscillator             | Recommended Constants | Item  | Conditions  | MIN. | TYP. | MAX.              | Unit |
|------------------------|-----------------------|---|---|------|------|-------------------|------|
| Ceramic <sup>2,3</sup> |                       | Oscillation frequency (f <sub>xx</sub> ) <sup>*1</sup>                |   | 1.0  |      | 5.0 <sup>*4</sup> | MHz  |
|                        |                       | Oscillation stabilization time <sup>*2</sup>                          | After V <sub>DD</sub> came to MIN. of oscillation voltage range |      |      | 4                 | ms   |
| Crystal                |                       | Oscillation frequency (f <sub>xx</sub> ) <sup>*1</sup>                |   | 1.0  | 4.19 | 5.0 <sup>*4</sup> | MHz  |
|                        |                       | Oscillation stabilization time <sup>*2</sup>                          |   |      |      | 10                | ms   |
| External Clock         |                       | X1 input frequency (f <sub>x</sub> ) <sup>*1</sup>                    |   | 1.0  |      | 5.0 <sup>*4</sup> | MHz  |
|                        |                       | X1 input high-, low-level widths (t <sub>xH</sub> , t <sub>xL</sub> ) |   | 100  |      | 500               | ns   |

\* 1: The oscillation frequency and X1 input frequency are indicated only to express the characteristics of the oscillator circuit.

For instruction execution time, refer to AC Characteristics.

2: Time required for oscillation to stabilize after V<sub>DD</sub> reaches the minimum value of the oscillation voltage range or the STOP mode has been released.

3: The oscillators below are recommended.

★ 4: When the oscillation frequency is 4.19 MHz < f<sub>x</sub> ≤ 5.0 MHz, do not select PCC = 0011 as the instruction execution time: otherwise, one machine cycle is set to less than 0.95 μs, falling short of the rated minimum value of 0.95 μs.

★ **Caution:** When using the oscillation circuit of the main system clock, wire the portion enclosed in dotted line in the figures as follows to avoid adverse influences on the wiring capacity:

- Keep the wiring length as short as possible.
- Do not cross the wiring over the other signal lines. Do not route the wiring in the vicinity of lines through which a high alternating current flows.
- Always keep the ground point of the capacitor of the oscillator circuit at the same potential as V<sub>DD</sub>. Do not connect the power source pattern through which a high current flows.
- Do not extract signals from the oscillation circuit.

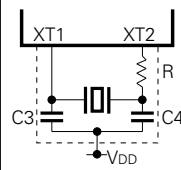
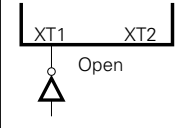
**RECOMMENDED OSCILLATION CIRCUIT CONSTANTS**

**MAIN SYSTEM CLOCK: CERAMIC OSCILLATOR (T<sub>a</sub> = -10 to +70°C)**

| Manufacturer          | Product Name | External Capacitance [pF] |                  | Oscillation Voltage Range [V] |      |
|-----------------------|--------------|---------------------------|------------------|-------------------------------|------|
|                       |              | C1                        | C2               | MIN.                          | MAX. |
| Murata Mfg. Co., Ltd. | CSA 2.00MG   | 30                        | 30               | 4.75                          | 5.25 |
|                       | CSA 4.19MG   | 30                        | 30               | 4.75                          | 5.25 |
|                       | CSA 4.19MGU  | 30                        | 30               | 4.75                          | 5.25 |
|                       | CST 4.19MG   | 30 pF (internal)          | 30 pF (internal) | 4.75                          | 5.25 |

**SUBSYSTEM CLOCK OSCILLATOR CIRCUIT CHARACTERISTICS**

( $T_a = -10$  to  $+70^\circ\text{C}$ ,  $V_{DD} = 5\text{ V} \pm 5\%$ )

| Oscillator     | Recommended Constants   | Item  | Conditions | MIN. | TYP.   | MAX. | Unit |
|----------------|---|---|------------|------|--------|------|------|
| Crystal        |  | Oscillation frequency ( $f_{XT}$ )                          |            | 32   | 32.768 | 35   | kHz  |
|                |   | Oscillation stabilization time*                             |            |      | 1.0    | 2    | s    |
| External Clock |  | XT1 input frequency ( $f_{XT}$ )                            |            | 32   |        | 100  | kHz  |
|                |   | XT1 input high-, low-level widths ( $t_{XTH}$ , $t_{XTL}$ ) |            | 5    |        | 15   | μs   |

\*: Time required for oscillation to stabilize after  $V_{DD}$  reaches the minimum value of the oscillation voltage range.

**Caution:** When using the oscillation circuit of the subsystem clock, wire the portion enclosed in dotted line ★ in the figures as follows to avoid adverse influences on the wiring capacity:

- Keep the wiring length as short as possible.
- Do not cross the wiring over the other signal lines. Do not route the wiring in the vicinity of lines through which a high alternating current flows.
- Always keep the ground point of the capacitor of the oscillator circuit at the same potential as  $V_{DD}$ . Do not connect the power source pattern through which a high current flows.
- Do not extract signals from the oscillation circuit.

The amplification factor of the subsystem clock oscillation circuit is designed to be low to reduce the current dissipation and therefore, the subsystem clock oscillation circuit is influenced by noise more easily than the main system clock oscillation circuit. When using the subsystem clock, therefore, exercise utmost care in wiring the circuit.

**CAPACITANCE** ( $T_a = 25^\circ\text{C}$ ,  $V_{DD} = 0\text{ V}$ )

| Parameter                | Symbol    | Conditions  | MIN. | TYP. | MAX. | Unit |
|--------------------------|-----------|---|------|------|------|------|
| Input Capacitance        | $C_{IN}$  | $f = 1\text{ MHz}$<br>Pins other than those measured are at 0 V |      |      | 15   | pF   |
| Output Capacitance       | $C_{OUT}$ |   |      |      | 15   | pF   |
| Input/Output Capacitance | $C_{IO}$  |   |      |      | 15   | pF   |

**DC CHARACTERISTICS** (T<sub>a</sub> = -10 to +70°C, V<sub>DD</sub> = 5V ±5%)

| Parameter                                 | Symbol                             | Conditions  | MIN.   | TYP. | MAX.                 | Unit               |    |
|---|------------------------------------|---|--|------|----------------------|--------------------|----|
| High-Level Input Voltage                  | V <sub>IH1</sub>                   | Ports 2, 3  | 0.7 V <sub>DD</sub>  |      | V <sub>DD</sub>      | V                  |    |
|   | V <sub>IH2</sub>                   | Ports 0, 1, 6, 7, $\overline{\text{RESET}}$                 | 0.8 V <sub>DD</sub>  |      | V <sub>DD</sub>      | V                  |    |
|   | V <sub>IH3</sub>                   | Ports 4, 5    Open-drain                                    | 0.7 V <sub>DD</sub>  |      | 10                   | V                  |    |
|   | V <sub>IH4</sub>                   | X1, X2, XT1   | V <sub>DD</sub> -0.5   |      | V <sub>DD</sub>      | V                  |    |
| Low-Level Input Voltage                   | V <sub>IL1</sub>                   | Ports 2, 3, 4, 5  | 0  |      | 0.3 V <sub>DD</sub>  | V                  |    |
|   | V <sub>IL2</sub>                   | Ports 0, 1, 6, 7, $\overline{\text{RESET}}$                 | 0  |      | 0.2 V <sub>DD</sub>  | V                  |    |
|   | V <sub>IL3</sub>                   | X1, X2, XT1   | 0  |      | 0.4                  | V                  |    |
| High-Level Output Voltage                 | V <sub>OH1</sub>                   | Ports 0, 2, 3, 6, 7<br>BIAS                                 | I <sub>OH</sub> = -1mA   |      | V <sub>DD</sub> -1.0 | V                  |    |
|   | V <sub>OH2</sub>                   | BP0-7   | I <sub>OH</sub> = -100μA* <sup>1</sup>   |      | V <sub>DD</sub> -2.0 | V                  |    |
| Low-Level Output Voltage                  | V <sub>OL1</sub>                   | Ports 0, 2, 3, 6, 7   | Ports 3, 4, 5<br>I <sub>OL</sub> = 15mA  |      | 0.4                  | 2.0                | V  |
|   |                                    |   | I <sub>OL</sub> = 1.6mA  |      |                      | 0.4                | V  |
|   | V <sub>OL2</sub>                   | SB0, 1<br>Open-drain  | Pull-up R ≥ 1kΩ  |      |                      | 0.2V <sub>DD</sub> | V  |
| V <sub>OL3</sub>                          | BP0-7                              | I <sub>OL</sub> = 100μA* <sup>1</sup>                       |  |      | 1.0                  | V                  |    |
| High-Level Input Leakage Current          | I <sub>LIH1</sub>                  | V <sub>IN</sub> = V <sub>DD</sub>                           | Other than below   |      | 3                    | μA                 |    |
|   | I <sub>LIH2</sub>                  |   | X1, X2, XT1  |      | 20                   | μA                 |    |
|   | I <sub>LIH3</sub>                  | V <sub>IN</sub> = 10V                                       | Ports 4, 5   |      | 20                   | μA                 |    |
| Low-Level Input Leakage Current           | I <sub>LIL1</sub>                  | V <sub>IN</sub> = 0V  | Other than below   |      | -3                   | μA                 |    |
|   | I <sub>LIL2</sub>                  |   | X1, X2, XT1  |      | -20                  | μA                 |    |
| High-Level Output Leakage Current         | I <sub>LOH1</sub>                  | V <sub>OUT</sub> = V <sub>DD</sub>                          | Other than below   |      | 3                    | μA                 |    |
|   | I <sub>LOH2</sub>                  | V <sub>OUT</sub> = 10V                                      | Ports 4,5  |      | 20                   | μA                 |    |
| Low-Level Output Leakage Current          | I <sub>LOL</sub>                   | V <sub>OUT</sub> = 0V                                       |  |      | -3                   | μA                 |    |
| Internal Pull-Up Resistor                 | R <sub>LI</sub>                    | Ports 0, 1, 2, 3, 6, 7<br>(except P00) V <sub>IN</sub> = 0V | 15   | 40   | 80                   | KΩ                 |    |
| LCD Drive Voltage                         | V <sub>LCD</sub>                   |   | 2.5  |      | V <sub>DD</sub>      | V                  |    |
| LCD Output Voltage Deviation<br>(Common)  | * <sup>2</sup><br>V <sub>ODC</sub> | I <sub>o</sub> = ±5 μA                                      | V <sub>LCD0</sub> = V <sub>LCD</sub><br>V <sub>LCD1</sub> = V <sub>LCD</sub> × $\frac{2}{3}$       | 0    |                      | ±0.2V              | V  |
| LCD Output Voltage Deviation<br>(Segment) | * <sup>2</sup><br>V <sub>ODS</sub> | I <sub>o</sub> = ±1 μA                                      | V <sub>LCD2</sub> = V <sub>LCD</sub> × $\frac{1}{3}$<br>2.7 V ≤ V <sub>LCD</sub> ≤ V <sub>DD</sub> | 0    |                      | ±0.2V              | V  |
| Supply Current                            | * <sup>3</sup><br>I <sub>DD1</sub> | 4.19MHz crystal * <sup>4</sup>                              | * <sup>6</sup>   | 5    | 15                   | mA                 |    |
|   | I <sub>DD2</sub>                   | oscillator<br>C1 = C2 = 22pF                                | HALT mode  | 500  | 1500                 | μA                 |    |
|   | I <sub>DD3</sub>                   | 32 kHz<br>crystal oscillator                                | * <sup>5</sup><br>HALT mode  |      | 350                  | 1000               | μA |
|   |                                    |   |  |      | 35                   | 100                |    |
| I <sub>DD4</sub>                          | XT1 = 0V<br>STOP mode              |   |  | 0.5  | 20                   | μA                 |    |

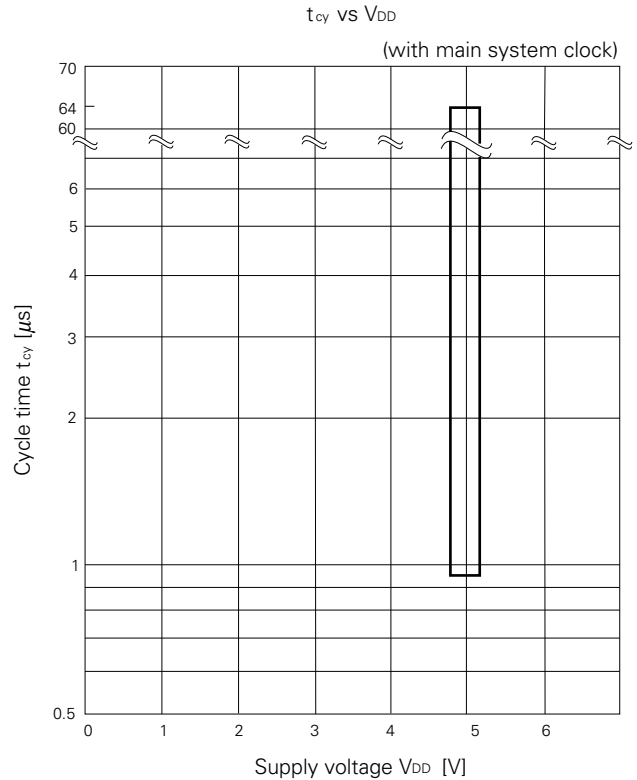
- \* 1: When using two of BP0-BP3 and two of BP4-BP7 for output at the same time.
- 2: "Voltage deviation" means the difference between the ideal segment or common output value (V<sub>LCDn</sub>: = 0, 1, 2) and output voltage.
- 3: Currents for the built-in pull-up resistor are not included.
- 4: Including when the subsystem clock is operated.
- 5: When operated with the subsystem clock by setting the system clock control register (SCC) to 1001 to stop the main system clock operation.
- 6: When operand in the high-speed mode with the processor clock control register (PCC) set to 0011.

**AC CHARACTERISTICS** ( $T_a = -10$  to  $+70^\circ\text{C}$ ,  $V_{DD} = 5\text{V} \pm 5\%$ )

**Operation Other Than Serial Transfer**

| Parameter  | Symbol             | Conditions          | MIN. | TYP. | MAX. | Unit          |
|--|--------------------|---------------------|------|------|------|---------------|
| CPU Clock Cycle Time* <sup>1</sup><br>(Minimum Instruction Execution Time = 1 Machine Cycle) | $t_{CY}$           | w/main system clock | 0.95 |      | 64   | $\mu\text{s}$ |
|  |                    | w/subsystem clock   | 114  | 122  | 125  | $\mu\text{s}$ |
| TIO Input Frequency  | $f_{TI}$           |                     | 0    |      | 1    | MHz           |
| TIO Input High-, Low-Level Widths  | $t_{TIH}, t_{TIL}$ |                     | 0.48 |      |      | $\mu\text{s}$ |
| Interrupt Input High-, Low-Level Widths  | $t_{INTH}$         | INT0                | *2   |      |      | $\mu\text{s}$ |
|  | $t_{INTL}$         | KR0-7, INT1, 2, 4   | 10   |      |      | $\mu\text{s}$ |
| RESET Low-Level Width  | $t_{RSL}$          |                     | 10   |      |      | $\mu\text{s}$ |

- \* 1: The CPU clock ( $\Phi$ ) cycle time is determined by the oscillation frequency of the connected oscillator, system clock control register (SCC), and processor clock control register (PCC).  
The figure on the right is cycle time  $t_{CY}$  vs. supply voltage  $V_{DD}$  characteristics at the main system clock.
- 2:  $2t_{CY}$  or  $128/f_{XX}$  depending on the setting of the interrupt mode register (IM0).



**SERIAL TRANSFER OPERATION**

**TWO-LINE AND THREE-LINE SERIAL I/O MODES ( $\overline{\text{SCK}}$ : internal clock output)**

| Parameter  | Symbol                           | Conditions                                    | MIN.                   | TYP. | MAX. | Unit |
|--|----------------------------------|---|------------------------|------|------|------|
| $\overline{\text{SCK}}$ Cycle Time                                 | $t_{\text{KCY1}}$                | Output  | 1600                   |      |      | ns   |
| $\overline{\text{SCK}}$ High-, Low-Level Widths                    | $t_{\text{KH1}}, t_{\text{KL1}}$ | Output  | $t_{\text{KCY1}}/2-50$ |      |      | ns   |
| SI Set-Up Time (vs. $\overline{\text{SCK}}\uparrow$ )              | $t_{\text{SIK1}}$                |   | 150                    |      |      | ns   |
| SI Hold Time (vs. $\overline{\text{SCK}}\uparrow$ )                | $t_{\text{KSI1}}$                |   | 400                    |      |      | ns   |
| $\overline{\text{SCK}}\downarrow \rightarrow$ SO Output Delay Time | $t_{\text{KS01}}$                | $R_L = 1\text{k}\Omega, C_L = 100\text{pF}^*$ |                        |      | 250  | ns   |

★ \*:  $R_L$  and  $C_L$  are load resistance and load capacitance of the SO output line.

**TWO-LINE AND THREE-LINE SERIAL I/O MODES ( $\overline{\text{SCK}}$ : external clock input)**

| Parameter  | Symbol                           | Conditions                                    | MIN. | TYP. | MAX. | Unit |
|--|----------------------------------|---|------|------|------|------|
| $\overline{\text{SCK}}$ Cycle Time                                 | $t_{\text{KCY2}}$                | Input   | 800  |      |      | ns   |
| $\overline{\text{SCK}}$ High-, Low-Level Widths                    | $t_{\text{KH2}}, t_{\text{KL2}}$ | Input   | 400  |      |      | ns   |
| SI Set-Up Time (vs. $\overline{\text{SCK}}\uparrow$ )              | $t_{\text{SIK2}}$                |   | 100  |      |      | ns   |
| SI Hold Time (vs. $\overline{\text{SCK}}\uparrow$ )                | $t_{\text{KSI2}}$                |   | 400  |      |      | ns   |
| $\overline{\text{SCK}}\downarrow \rightarrow$ SO Output Delay Time | $t_{\text{KS02}}$                | $R_L = 1\text{k}\Omega, C_L = 100\text{pF}^*$ |      |      | 300  | ns   |

★ \*:  $R_L$  and  $C_L$  are load resistance and load capacitance of the SO output line.

**SBI MODE ( $\overline{\text{SCK}}$ : internal clock output (master))**

| Parameter  | Symbol                               | Conditions                                    | MIN.                      | TYP. | MAX. | Unit |
|--|--------------------------------------|---|---------------------------|------|------|------|
| $\overline{\text{SCK}}$ Cycle Time                                     | $t_{\text{KCY3}}$                    |   | 1600                      |      |      | ns   |
| $\overline{\text{SCK}}$ High-, Low-Level Widths                        | $t_{\text{KL3}}$<br>$t_{\text{KH3}}$ |   | $t_{\text{KCY}}/2$<br>-50 |      |      | ns   |
| SB0, 1 Set-Up Time (vs. $\overline{\text{SCK}}\uparrow$ )              | $t_{\text{SIK3}}$                    |   | 150                       |      |      | ns   |
| SB0, 1 Hold Time (vs. $\overline{\text{SCK}}\uparrow$ )                | $t_{\text{KSI3}}$                    |   | $t_{\text{KCY}}/2$        |      |      | ns   |
| $\overline{\text{SCK}}\downarrow \rightarrow$ SB0, 1 Output Delay Time | $t_{\text{KSO3}}$                    | $R_L = 1\text{k}\Omega, C_L = 100\text{pF}^*$ | 0                         |      | 250  | ns   |
| $\overline{\text{SCK}}\uparrow \rightarrow$ SB0, 1 $\downarrow$        | $t_{\text{KSB}}$                     |   | $t_{\text{KCY}}$          |      |      | ns   |
| SB0, 1 $\downarrow \rightarrow \overline{\text{SCK}}\downarrow$        | $t_{\text{SBK}}$                     |   | $t_{\text{KCY}}$          |      |      | ns   |
| SB0, 1 Low-Level Width   | $t_{\text{SBL}}$                     |   | $t_{\text{KCY}}$          |      |      | ns   |
| SB0, 1 High-Level Width  | $t_{\text{SBH}}$                     |   | $t_{\text{KCY}}$          |      |      | ns   |

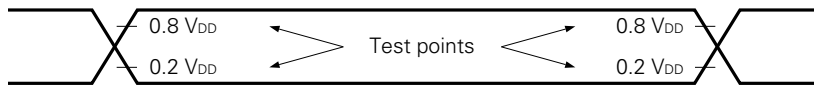
\*:  $R_L$  and  $C_L$  are load resistance and load capacitance of the SO output line. ★

**SBI MODE ( $\overline{\text{SCK}}$ : external clock output (master))**

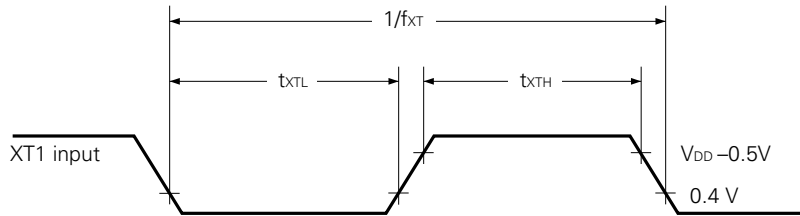
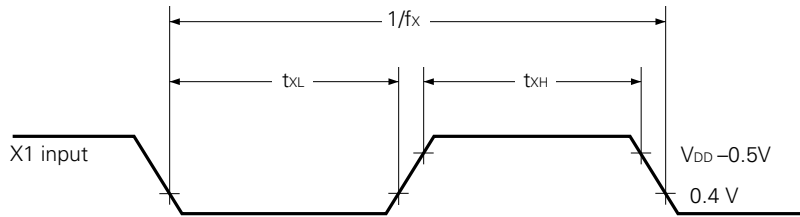
| Parameter  | Symbol                               | Conditions                                    | MIN.               | TYP. | MAX. | Unit |
|--|--------------------------------------|---|--------------------|------|------|------|
| $\overline{\text{SCK}}$ Cycle Time                                     | $t_{\text{KCY4}}$                    |   | 1600               |      |      | ns   |
| $\overline{\text{SCK}}$ High-, Low-Level Widths                        | $t_{\text{KL4}}$<br>$t_{\text{KH4}}$ |   | 400                |      |      | ns   |
| SB0, 1 Set-Up Time (vs. $\overline{\text{SCK}}\uparrow$ )              | $t_{\text{SIK4}}$                    |   | 100                |      |      | ns   |
| SB0, 1 Hold Time (vs. $\overline{\text{SCK}}\uparrow$ )                | $t_{\text{KSI4}}$                    |   | $t_{\text{KCY}}/2$ |      |      | ns   |
| $\overline{\text{SCK}}\downarrow \rightarrow$ SB0, 1 Output Delay Time | $t_{\text{KSO4}}$                    | $R_L = 1\text{k}\Omega, C_L = 100\text{pF}^*$ | 0                  |      | 300  | ns   |
| $\overline{\text{SCK}}\uparrow \rightarrow$ SB0, 1 $\downarrow$        | $t_{\text{KSB}}$                     |   | $t_{\text{KCY}}$   |      |      | ns   |
| SB0, 1 $\downarrow \rightarrow \overline{\text{SCK}}\downarrow$        | $t_{\text{SBK}}$                     |   | $t_{\text{KCY}}$   |      |      | ns   |
| SB0, 1 Low-Level Width   | $t_{\text{SBL}}$                     |   | $t_{\text{KCY}}$   |      |      | ns   |
| SB0, 1 High-Level Width  | $t_{\text{SBH}}$                     |   | $t_{\text{KCY}}$   |      |      | ns   |

\*:  $R_L$  and  $C_L$  are load resistance and load capacitance of the SO output line. ★

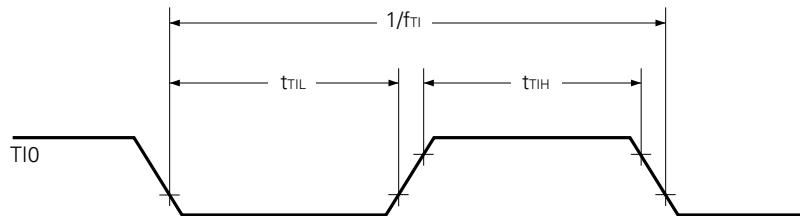
**AC TIMING TEST POINT** (excluding X1 and XT1 inputs)



**CLOCK TIMING**



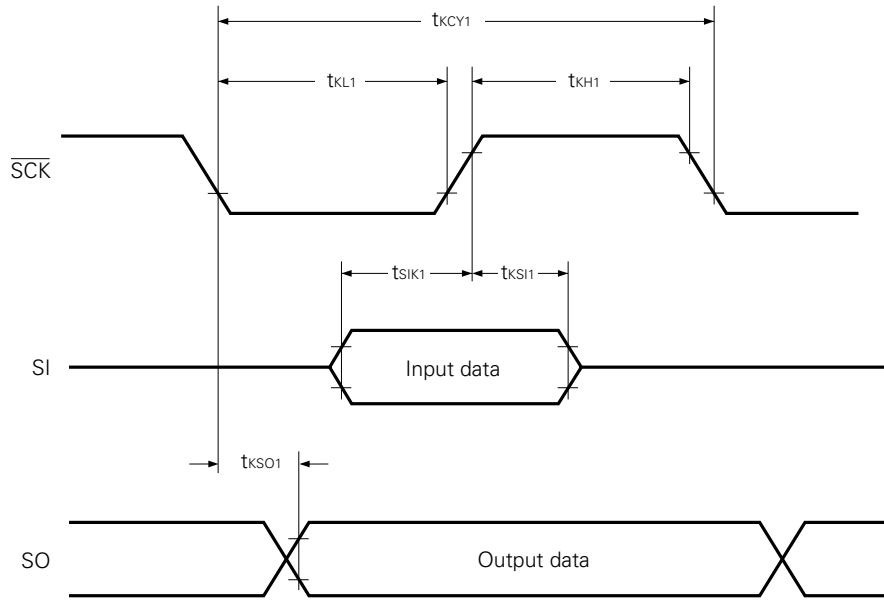
**T10 TIMING**



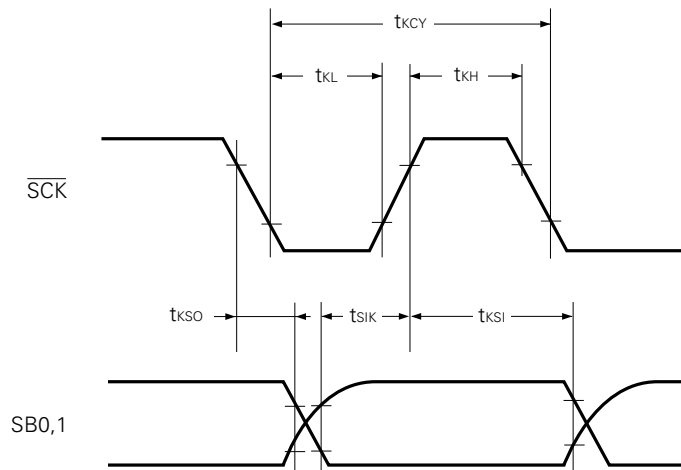


**SERIAL TRANSFER TIMING**

**THREE-LINE SERIAL I/O MODE:**

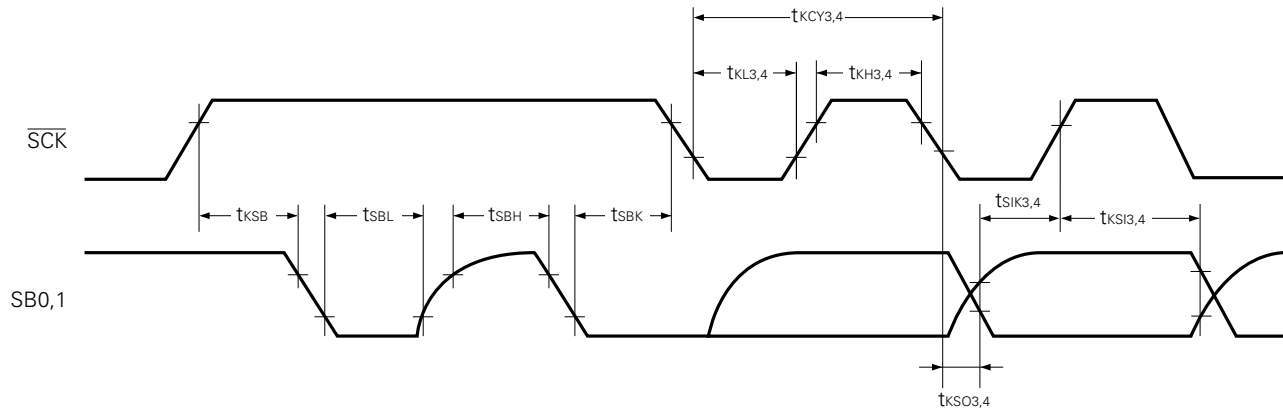


**TWO-LINE SERIAL I/O MODE:**

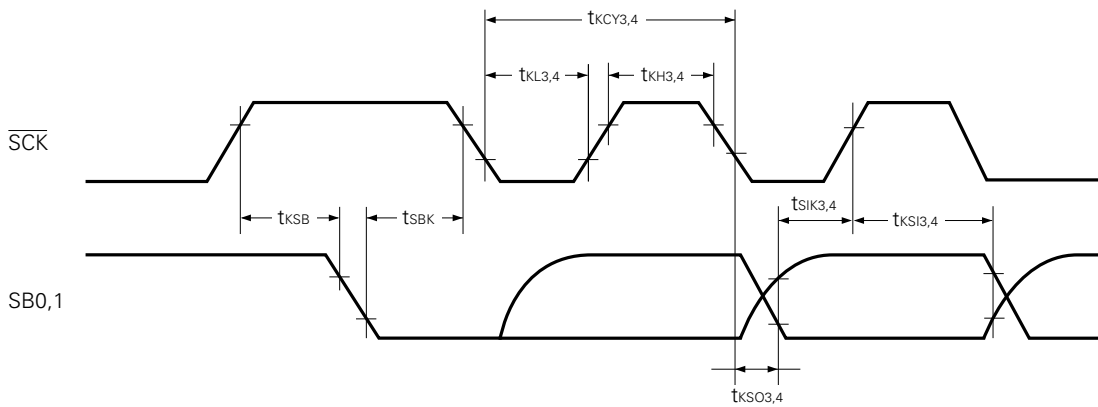


**SERIAL TRANSFER TIMING**

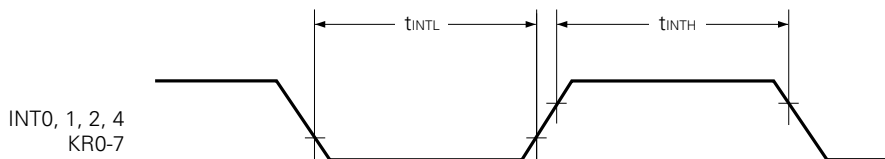
**BUS RELEASE SIGNAL TRANSFER**



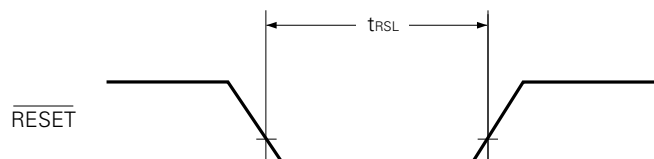
**COMMAND SIGNAL TRANSFER**



**INTERRUPT INPUT TIMING**



**RESET INPUT TIMING**



**LOW-VOLTAGE DATA RETENTION CHARACTERISTICS OF DATA MEMORY IN STOP MODE**

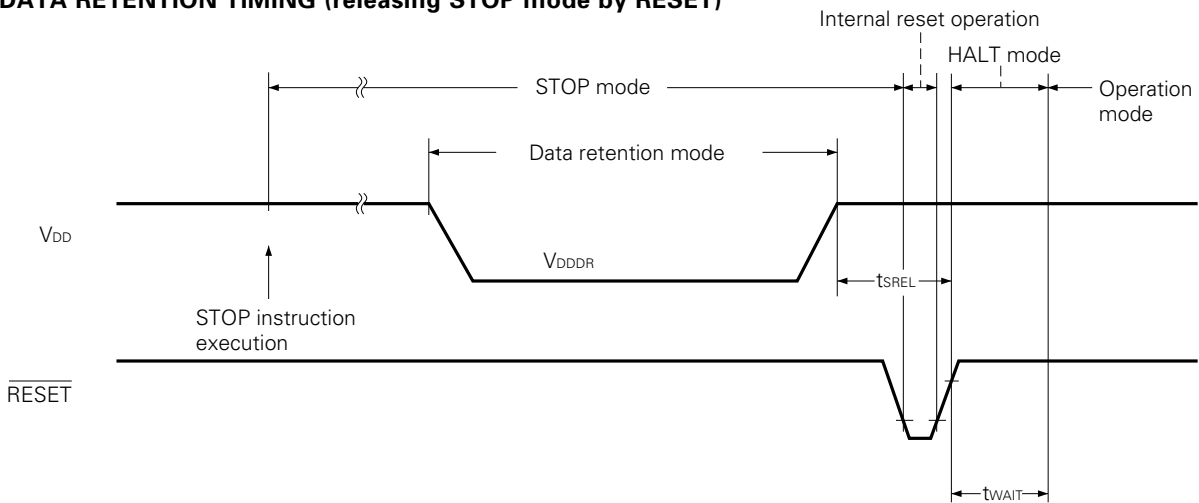
(T<sub>a</sub> = -10 to +70°C)

| Parameter                             | Symbol            | Conditions                            | MIN. | TYP.                            | MAX. | Unit |
|---------------------------------------|-------------------|---------------------------------------|------|---------------------------------|------|------|
| Data Retention Supply Voltage         | V <sub>DDDR</sub> |                                       | 2.0  |                                 | 6.0  | V    |
| Data Retention Supply Current*1       | I <sub>DDDR</sub> | V <sub>DDDR</sub> = 2.0V              |      | 0.1                             | 10   | μA   |
| Release Signal Set Time               | t <sub>SREL</sub> |                                       | 0    |                                 |      | μs   |
| Oscillation Stabilization Wait Time*2 | t <sub>WAIT</sub> | Released by $\overline{\text{RESET}}$ |      | 2 <sup>17</sup> /f <sub>x</sub> |      | ms   |
|                                       |                   | Released by interrupt                 |      | *3                              |      | ms   |

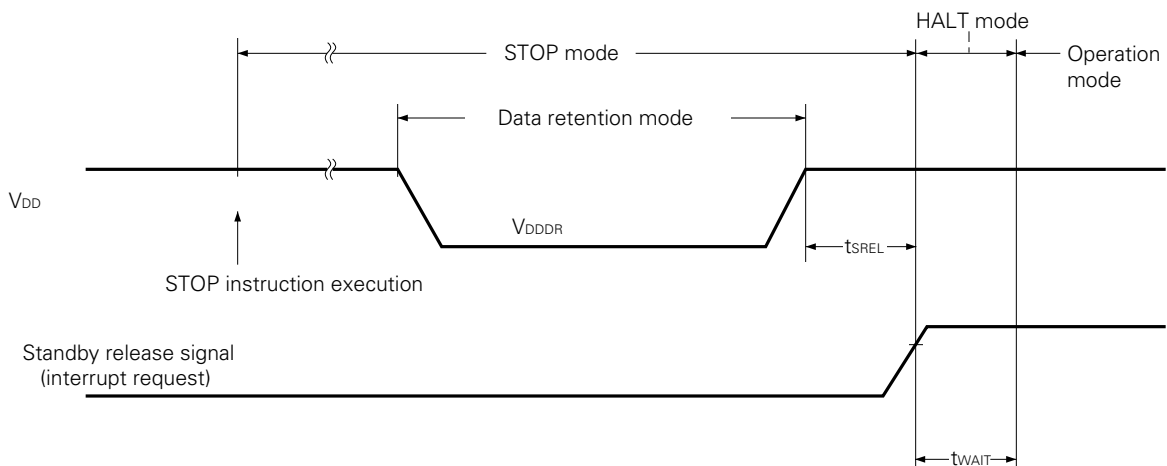
- \*1: Does not include current flowing through internal pull-up resistor
- 2: The oscillation stabilization wait time is the time during which the CPU is stopped to prevent unstable operation when oscillation is started.
- 3: Depends on the setting of the basic interval timer mode register (BTM) as follows:

| BTM3 | BTM2 | BTM1 | BTM0 | WAIT time ( ): f <sub>x</sub> = 4.19 MHz          |
|------|------|------|------|---|
| —    | 0    | 0    | —    | 2 <sup>20</sup> /f <sub>x</sub> (approx. 250 ms)  |
| —    | 0    | 1    | —    | 2 <sup>17</sup> /f <sub>x</sub> (approx. 31.3 ms) |
| —    | 1    | 0    | —    | 2 <sup>15</sup> /f <sub>x</sub> (approx. 7.82 ms) |
| —    | 1    | 1    | —    | 2 <sup>13</sup> /f <sub>x</sub> (approx. 1.95 ms) |

**DATA RETENTION TIMING (releasing STOP mode by  $\overline{\text{RESET}}$ )**



**DATA RETENTION TIMING (standby release signal: releasing STOP mode by interrupt)**



**DC PROGRAMMING CHARACTERISTICS** ( $T_a = 25 \pm 5^\circ\text{C}$ ,  $V_{DD} = 6.0 \pm 0.25\text{V}$ ,  $V_{PP} = 12.5 \pm 0.3\text{V}$ ,  $V_{SS} = 0\text{V}$ )

| Parameter                 | Symbol    | Conditions                      | MIN.           | TYP. | MAX.         | Unit |
|---------------------------|-----------|---------------------------------|----------------|------|--------------|------|
| High-Level Input Voltage  | $V_{IH1}$ | Other than X1 or X2             | 0.7 $V_{DD}$   |      | $V_{DD}$     | V    |
|                           | $V_{IH2}$ | X1 and X2                       | $V_{DD} - 0.5$ |      | $V_{DD}$     | V    |
| Low-Level Input Voltage   | $V_{IL1}$ | Other than X1 or X2             | 0              |      | 0.3 $V_{DD}$ | V    |
|                           | $V_{IL2}$ | X1 and X2                       | 0              |      | 0.4          | V    |
| Input Leakage Current     | $I_{LI}$  | $V_{IN} = V_{IL}$ or $V_{IH}$   |                |      | 10           | μA   |
| High-Level Output Voltage | $V_{OH}$  | $I_{OH} = -1 \text{ mA}$        | $V_{DD} - 1.0$ |      |              | V    |
| Low-Level Output Voltage  | $V_{OL}$  | $I_{OL} = 1.6 \text{ mA}$       |                |      | 0.4          | V    |
| $V_{DD}$ Supply Current   | $I_{DD}$  |                                 |                |      | 30           | mA   |
| $V_{PP}$ Supply Current   | $I_{PP}$  | $MD0 = V_{IL}$ , $MD1 = V_{IH}$ |                |      | 30           | mA   |

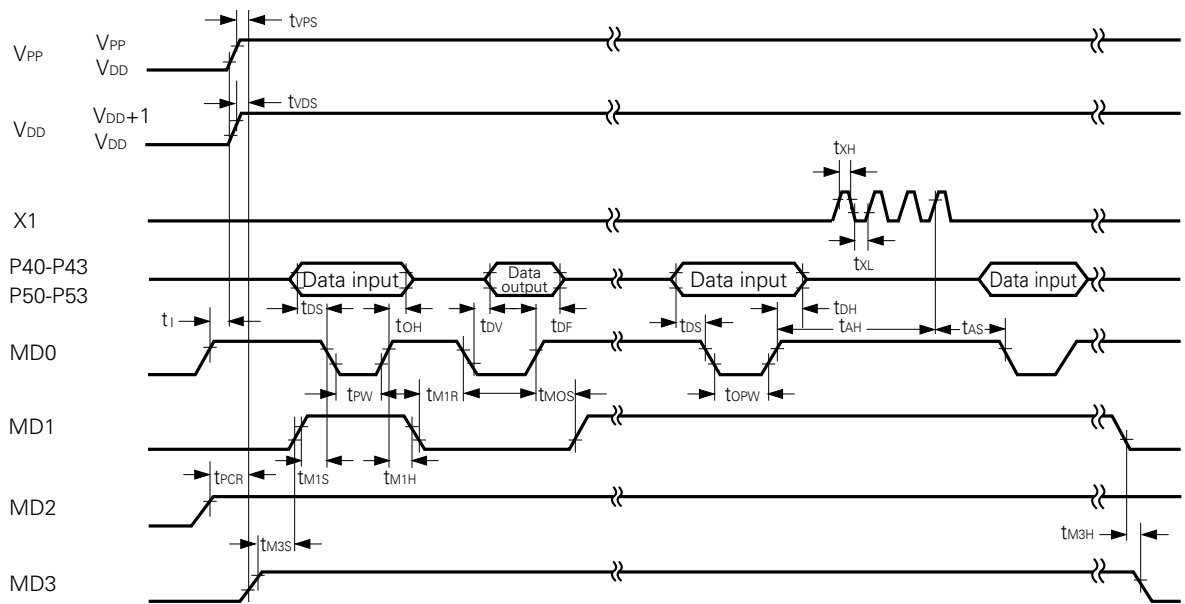
- Notes** 1:  $V_{PP}$  must not exceed +13.5 V, including the overshoot.  
 2: Apply  $V_{DD}$  before  $V_{PP}$  and disconnect it after  $V_{PP}$ .

**AC PROGRAMMING CHARACTERISTICS** ( $T_a = 25 \pm 5^\circ\text{C}$ ,  $V_{DD} = 6.0 \pm 0.25\text{V}$ ,  $V_{PP} = 12.5 \pm 0.3\text{V}$ ,  $V_{SS} = 0\text{V}$ )

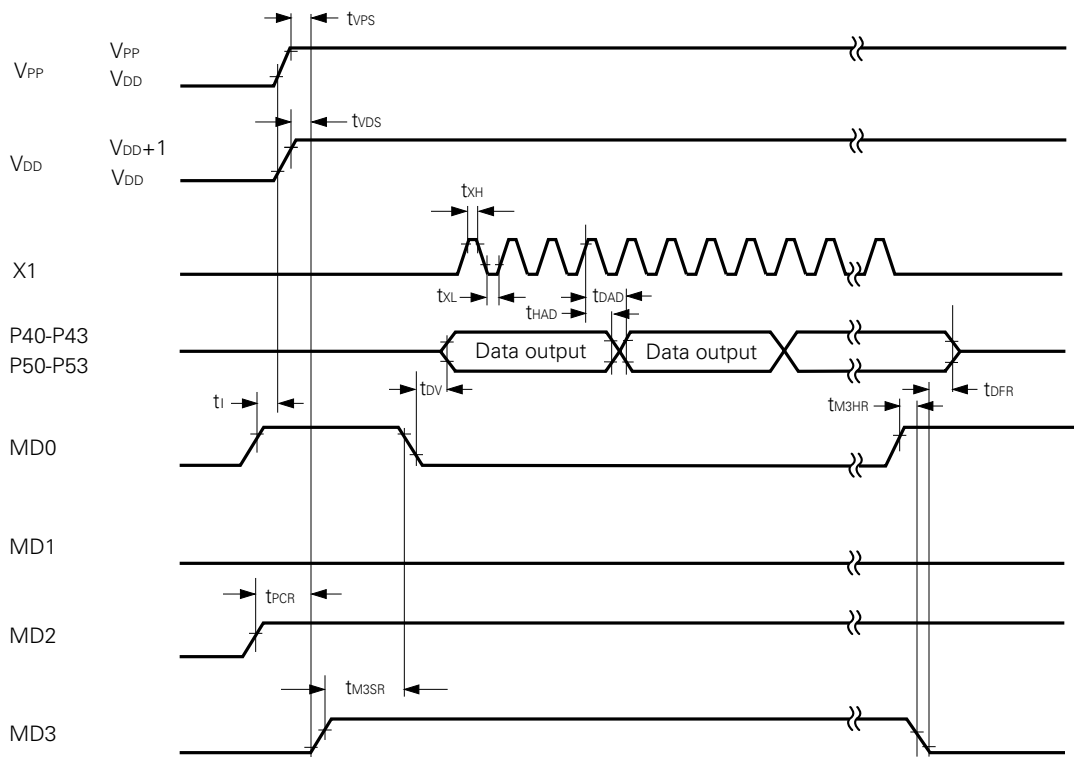
| Parameter                              | Symbol           | *1        | Conditions                              | MIN.  | TYP. | MAX. | Unit |
|--|------------------|-----------|---|-------|------|------|------|
| Address Set-Up Time*2 (vs. MD0↓)       | $t_{AS}$         | $t_{AS}$  |   | 2     |      |      | μs   |
| MD1 Set-Up Time (vs. MD0↓)             | $t_{M1S}$        | $t_{OES}$ |   | 2     |      |      | μs   |
| Data Set-Up Time (vs. MD0↓)            | $t_{DS}$         | $t_{DS}$  |   | 2     |      |      | μs   |
| Address Hold Time*2 (vs. MD0↑)         | $t_{AH}$         | $t_{AH}$  |   | 2     |      |      | μs   |
| Data Hold Time (vs. MD0↑)              | $t_{DH}$         | $t_{DH}$  |   | 2     |      |      | μs   |
| MD0 ↑ → Data Output Float Delay Time   | $t_{DF}$         | $t_{DF}$  |   | 0     |      | 130  | ns   |
| $V_{PP}$ Set-Up Time (vs. MD3↑)        | $t_{VPS}$        | $t_{VPS}$ |   | 2     |      |      | μs   |
| $V_{DD}$ Set-Up Time (vs. MD3↑)        | $t_{VDS}$        | $t_{VCS}$ |   | 2     |      |      | μs   |
| Initial Program Pulse Width            | $t_{PW}$         | $t_{PW}$  |   | 0.95  | 1.0  | 1.05 | ms   |
| Additional Program Pulse Width         | $t_{OPW}$        | $t_{OPW}$ |   | 0.95  |      | 21.0 | ms   |
| MD0 Set-Up Time (vs. MD1↑)             | $t_{MOS}$        | $t_{CES}$ |   | 2     |      |      | μs   |
| MD0 ↓ → Data Output Delay Time         | $t_{DV}$         | $t_{DV}$  | $MD0 = MD1 = V_{IL}$                    |       |      | 1    | μs   |
| MD1 Hold Time (vs. MD0↑)               | $t_{M1H}$        | $t_{OEH}$ | $t_{M1H} + t_{M1R} \geq 50 \mu\text{s}$ | 2     |      |      | μs   |
| MD1 Recovery Time (vs. MD0↓)           | $t_{M1R}$        | $t_{OR}$  |   | 2     |      |      | μs   |
| Program Counter Reset Time             | $t_{PCR}$        | –         |   | 10    |      |      | μs   |
| X1 Input High-/Low- Level Width        | $t_{XH}, t_{XL}$ | –         |   | 0.125 |      |      | μs   |
| X1 Input Frequency                     | $f_X$            | –         |   |       |      | 4.19 | MHz  |
| Initial Mode Set Time                  | $t_I$            | –         |   | 2     |      |      | μs   |
| MD3 Set-Up Time (vs. MD1↑)             | $t_{M3S}$        | –         |   | 2     |      |      | μs   |
| MD3 Hold Time (vs. MD1↓)               | $t_{M3H}$        | –         |   | 2     |      |      | μs   |
| MD3 Set-Up Time (vs. MD0↓)             | $t_{M3SR}$       | –         | When data is read from program memory   | 2     |      |      | μs   |
| ★ Address*2 → Data Output Delay Time   | $t_{DAD}$        | $t_{ACC}$ | When data is read from program memory   |       |      | 2    | μs   |
| Address*2 → Data Output Hold Time      | $t_{HAD}$        | $t_{OH}$  | When data is read from program memory   | 0     |      | 130  | ns   |
| MD3 Hold Time (vs. MD0↑)               | $t_{M3HR}$       | –         | When data is read from program memory   | 2     |      |      | μs   |
| ★ MD3 ↓ → Data Output Float Delay Time | $t_{DFR}$        | –         | When data is read from program memory   |       |      | 2    | μs   |

- \*1: These symbols are the corresponding μPD27C256 symbols.  
 2: The internal address signal is incremented by 1 at the fourth rising edge of X1 input. The internal address is not connected to any pin.

**PROGRAM MEMORY WRITE TIMING**

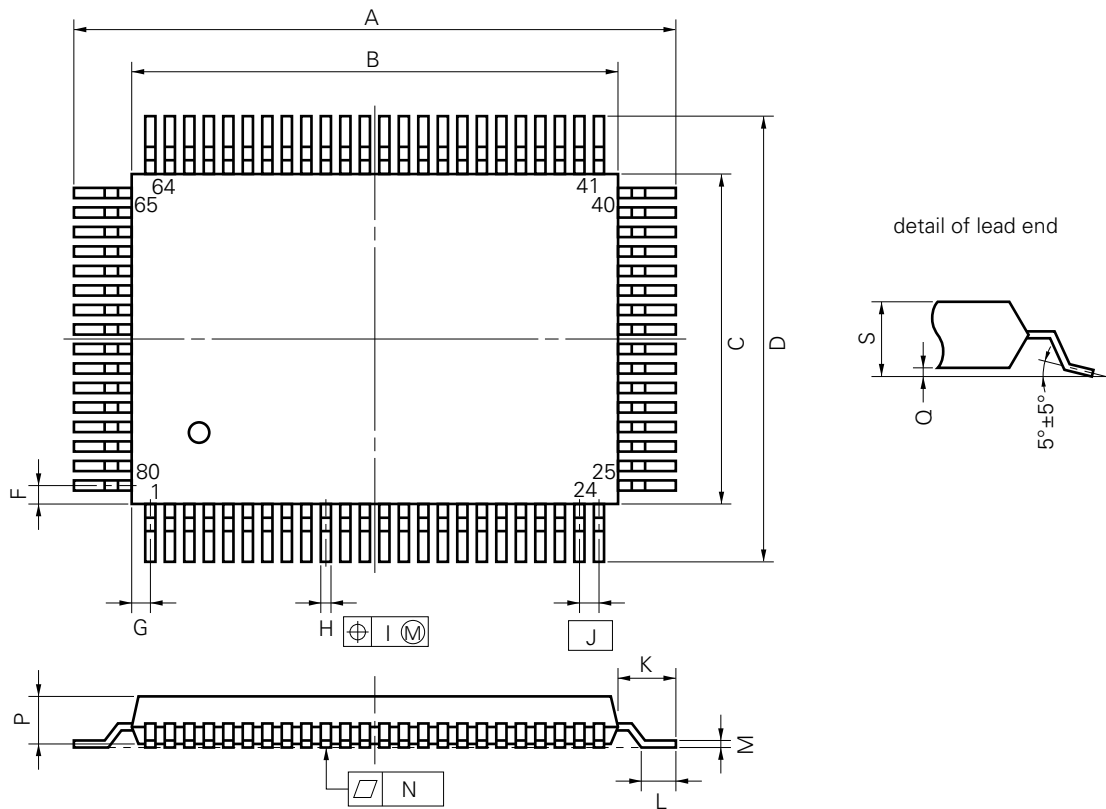


**PROGRAM MEMORY READ TIMING**



5. PACKAGE DRAWINGS

80 PIN PLASTIC QFP (14x20)



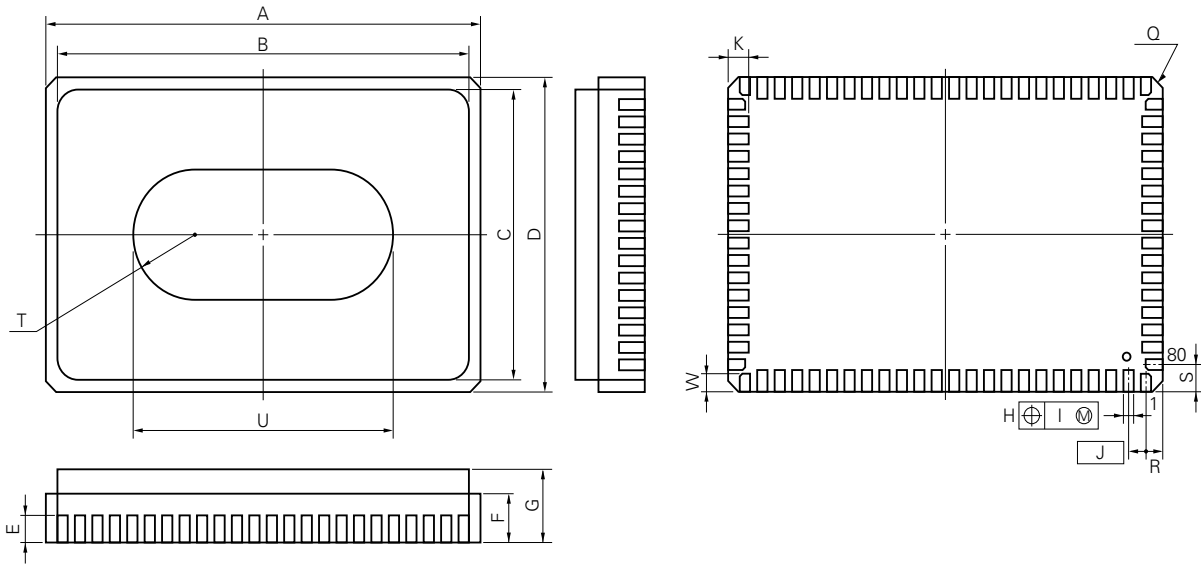
**NOTE**

Each lead centerline is located within 0.15 mm (0.006 inch) of its true position (T.P.) at maximum material condition.

P80GF-80-3B9-2

| ITEM | MILLIMETERS                            | INCHES                                    |
|------|--|---|
| A    | 23.6±0.4                               | 0.929±0.016                               |
| B    | 20.0±0.2                               | 0.795 <sup>+0.009</sup> <sub>-0.008</sub> |
| C    | 14.0±0.2                               | 0.551 <sup>+0.009</sup> <sub>-0.008</sub> |
| D    | 17.6±0.4                               | 0.693±0.016                               |
| F    | 1.0                                    | 0.039                                     |
| G    | 0.8                                    | 0.031                                     |
| H    | 0.35±0.10                              | 0.014 <sup>+0.004</sup> <sub>-0.005</sub> |
| I    | 0.15                                   | 0.006                                     |
| J    | 0.8 (T.P.)                             | 0.031 (T.P.)                              |
| K    | 1.8±0.2                                | 0.071 <sup>+0.008</sup> <sub>-0.009</sub> |
| L    | 0.8±0.2                                | 0.031 <sup>+0.009</sup> <sub>-0.008</sub> |
| M    | 0.15 <sup>+0.10</sup> <sub>-0.05</sub> | 0.006 <sup>+0.004</sup> <sub>-0.003</sub> |
| N    | 0.15                                   | 0.006                                     |
| P    | 2.7                                    | 0.106                                     |
| Q    | 0.1±0.1                                | 0.004±0.004                               |
| S    | 3.0 MAX.                               | 0.119 MAX.                                |

80 PIN CERAMIC WQFN



**NOTE**

Each lead centerline is located within 0.08 mm (0.003 inch) of its true position (T.P.) at maximum material condition.

X80KW-80A-1

| ITEM | MILLIMETERS | INCHES                                    |
|------|-------------|---|
| A    | 20.0±0.4    | 0.787 <sup>+0.017</sup> <sub>-0.016</sub> |
| B    | 19.0        | 0.748                                     |
| C    | 13.2        | 0.520                                     |
| D    | 14.2±0.4    | 0.559±0.016                               |
| E    | 1.64        | 0.065                                     |
| F    | 2.14        | 0.084                                     |
| G    | 4.064 MAX.  | 0.160 MAX.                                |
| H    | 0.51±0.10   | 0.020±0.004                               |
| I    | 0.08        | 0.003                                     |
| J    | 0.8 (T.P.)  | 0.031 (T.P.)                              |
| K    | 1.0±0.2     | 0.039 <sup>+0.009</sup> <sub>-0.008</sub> |
| Q    | C 0.5       | C 0.020                                   |
| R    | 0.8         | 0.031                                     |
| S    | 1.1         | 0.043                                     |
| T    | R 3.0       | R 0.118                                   |
| U    | 12.0        | 0.472                                     |
| W    | 0.75±0.2    | 0.030 <sup>+0.008</sup> <sub>-0.009</sub> |

★ **6. RECOMMENDED SOLDERING CONDITIONS**

It is recommended that μPD75P308 be soldered under the following conditions.

For details on the recommended soldering conditions, refer to Information Document "Semiconductor Devices Mounting Manual" (IEI-616).

The soldering methods and conditions are not listed here, consult NEC.

**Table 6-1 Soldering Conditions**

μPD75P308GF-3B9: 80-pin plastic QFP (14 x 20 mm)

| Soldering Method    | Soldering Conditions  | Symbol for Recommended Condition |
|---------------------|---|----------------------------------|
| Wave Soldering      | Soldering bath temperature: 260°C max., time: 10 seconds max., number of times: 1, pre-heating temperature: 120°C max. (package surface temperature), maximum number of days: 2 days*, (beyond this period, 16 hours of pre-baking is required at 125°C). | WS60-162-1                       |
| Infrared Reflow     | Package peak temperature: 230°C, time: 30 seconds max. (210°C min.), number of times: 1, maximum number of days: 2 days* (beyond this period, 16 hours of pre-baking is required at 125°C)  | IR30-162-1                       |
| VPS                 | Package peak temperature: 215°C, time: 40 seconds max. (200°C min.), number of times: 1, maximum number of days: 2 days* (beyond this period, 16 hours of pre-baking is required at 125°C)  | VP15-162-1                       |
| Pin Partial Heating | Pin temperature: 300°C max., time: 3 seconds max. (per side)  | —                                |

\*: Number of days after unpacking the dry pack. Storage conditions are 25°C and 65%RH max.

**Caution: Do not use two or more soldering methods in combination (except the pin partial heating method).**

**Notice**

**A model that can be soldered under the more stringent conditions (infrared reflow peak temperature: 235°C, number of times: 2, and an extended number of days) is also available. For details, consult NEC.**



**APPENDIX A. DEVELOPMENT TOOLS**

The following development support tools are readily available to support development of systems using μPD75P308:

*PROM writing tools*

|            |   |   |
|------------|---|---|
| Hardware   | IE-75000-R <sup>*1</sup>  | In-circuit emulator for 75K series  |
|            | IE-75001-R  |   |
|            | IE-75000-R-EM <sup>*2</sup>   | Emulation board for IE-75000-R and IE-75001-R   |
|            | EP-75308GF-R  | Emulation prove for μPD75P308GF, provided with 80-pin conversion socket, EV-9200G-80.   |
|            | EV-9200G-80   |   |
|            | PG-1500   | PROM programmer   |
|            | PA-75P308GF   | PROM programmer adapter solely used for μPD75P308GF. It is connected to PG-1500.  |
| PA-75P308K | PROM programmer adapter solely used for μPD75P308K. It is connected to PG-1500. |   |
| Software   | IE Control Program  | Host machine<br><ul style="list-style-type: none"> <li>• PC-9800 series (MS-DOS™ Ver.3.30 to Ver.5.00A<sup>*3</sup>)</li> <li>• IBM PC/AT™ (PC DOS™ Ver.3.1)</li> </ul> |
|            | PG-1500 Controller  |   |
|            | RA75X Relocatable Assembler   |   |

\*1: Maintenance product

2: Not provided with IE-75001-R

3: Ver.5.00/5.00A has a task swap function, but this function cannot be used with this software.

**Remarks:** For development tools from other companies, refer to 75X Series Selection Guide (IF-151).

★ APPENDIX B. RELATED DOCUMENTS

## GENERAL NOTES ON CMOS DEVICES

**① STATIC ELECTRICITY (ALL MOS DEVICES)**

**Exercise care so that MOS devices are not adversely influenced by static electricity while being handled.**

The insulation of the gates of the MOS device may be destroyed by a strong static charge. Therefore, when transporting or storing the MOS device, use a conductive tray, magazine case, or conductive buffer materials, or the metal case NEC uses for packaging and shipment, and use grounding when assembling the MOS device system. Do not leave the MOS device on a plastic plate and do not touch the pins of the device.

Handle boards on which MOS devices are mounted similarly .

**② PROCESSING OF UNUSED PINS (CMOS DEVICES ONLY)**

**Fix the input level of CMOS devices.**

Unlike bipolar or NMOS devices, if a CMOS device is operated with nothing connected to its input pin, intermediate level input may be generated due to noise, and an inrush current may flow through the device, causing the device to malfunction. Therefore, fix the input level of the device by using a pull-down or pull-up resistor. If there is a possibility that an unused pin serves as an output pin (whose timing is not specified), each pin should be connected to  $V_{DD}$  or GND through a resistor.

Refer to "Processing of Unused Pins" in the documents of each devices.

**③ STATUS BEFORE INITIALIZATION (ALL MOS DEVICES)**

**The initial status of MOS devices is undefined upon power application.**

Since the characteristics of an MOS device are determined by the quantity of injection at the molecular level, the initial status of the device is not controlled during the production process. The output status of pins, I/O setting, and register contents upon power application are not guaranteed. However, the items defined for reset operation and mode setting are subject to guarantee after the respective operations have been executed.

When using a device with a reset function, be sure to reset the device after power application.

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Standard: Computer, Office equipment, Communication equipment, Test and Measurement equipment, Machine tools, Industrial robots, Audio and Visual equipment, Other consumer products, etc.

Special: Automotive and Transportation equipment, Traffic control systems, Antidisaster systems, Anticrime system, etc.

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